## MC33696

## PLL Tuned UHF Transceiver for Data Transfer Applications

## 1 Overview

The MC33696 is a highly integrated transceiver designed for low-voltage applications. It includes a programmable PLL for multi-channel applications, an RSSI circuit, a strobe oscillator that periodically wakes up the receiver while a data manager checks the content of incoming messages. A configuration switching feature allows automatic changing of the configuration between two programmable settings without the need of an MCU.

## 2 Features

General:

- $304 \mathrm{MHz}, 315 \mathrm{MHz}, 426 \mathrm{MHz}, 434 \mathrm{MHz}$, 868 MHz , and 915 MHz ISM bands
- Choice of temperature ranges:
- $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$
- $-20^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$
- OOK and FSK transmission and reception
- 20 kbps maximum data rate using Manchester coding
- 2.1 V to 3.6 V or 5 V supply voltage
- Programmable via SPI
- 6 kHz PLL frequency step


## Features

- Frequency hopping capability with PLL toggle time below $30 \mu \mathrm{~s}$
- Current consumption:
- 13.5 mA in TX mode
- 10.3 mA in RX mode
- Less then 1 mA in RX mode with strobe ratio $=1 / 10$
- 260 nA standby and $24 \mu \mathrm{~A}$ off currents
- Configuration switching - allows fast switching of two register banks

Receiver:

- $\quad-106.5 \mathrm{dBm}$ sensitivity, up to -108 dBm in FSK 2.4 kbps
- Digital and analog RSSI (received signal strength indicator)
- Automatic wakeup function (strobe oscillator)
- Embedded data processor with programmable word recognition
- Image cancelling mixer
- 380 kHz IF filter bandwidth
- Fast wakeup time

Transmitter:

- Up to 7.25 dBm output power
- Programmable output power
- FSK done by PLL programming

Ordering information

| Temperature Range | QFN Package | LQFP Package |
| :---: | :---: | :---: |
| $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | MC33696FCE/R2 | MC33696FJE/R2 |
| $-20^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | MC33696FCAE/R2 | MC33696FJAE/R2 |



## Pin Functions

## Figure 1. Block Diagram

## 3 Pin Functions

Table 1. Pin Functions

| Pin | Name | Description |
| :---: | :---: | :---: |
| 1 | RSSIOUT | RSSI analog output |
| 2 | VCC2RF | 2.1 V to 2.7 V internal supply for LNA |
| 3 | RFIN | RF input |
| 4 | GNDLNA | Ground for LNA (low noise amplifier) |
| 5 | VCC2VCO | 2.1 V to 2.7 V internal supply for VCO |
| 6 | GNDPA1 | PA ground |
| 7 | RFOUT | RF output |
| 8 | GNDPA2 | PA ground |
| 9 | XTALIN | Crystal oscillator input |
| 10 | XTALOUT | Crystal oscillator output |
| 11 | VCCINOUT | 2.1 V to 3.6 V power supply/regulator output |
| 12 | VCC2OUT | 2.1 V to 2.7 V voltage regulator output for analog and RF modules |
| 13 | VCCDIG | 2.1 V to 3.6 V power supply for voltage limiter |
| 14 | VCCDIG2 | 1.5 V voltage limiter output for digital module |
| 15 | RBGAP | Reference voltage load resistance |
| 16 | GND | General ground |
| 17 | GNDDIG | Digital module ground |
| 18 | RSSIC | RSSI control input |
| 19 | DATACLK | Data clock output to microcontroller |
| 20 | CONFB | Configuration mode selection input |
| 21 | MISO | Digital interface I/O |
| 22 | MOSI | Digital interface I/O |
| 23 | SCLK | Digital interface clock I/O |
| 24 | SEB | Digital interface enable input |
| 25 | GNDIO | Digital I/O ground |
| 26 | VCCIN | 2.1 V to 3.6 V or 5.5 V input |
| 27 | NC | No connection |
| 28 | STROBE | Strobe oscillator capacitor or external control input |
| 29 | GNDSUBD | Ground |
| 30 | VCC2IN | 2.1 V to 2.7 V power supply for analog modules for decoupling capacitor |
| 31 | SWITCH | RF switch control output |
| 32 | GND | General ground |

## 4 Maximum Ratings

## Table 2. Maximum Ratings

| Parameter | Symbol | Value | Unit |
| :---: | :---: | :---: | :---: |
| Supply voltage on pin: VCCIN | $\mathrm{V}_{\text {CCIN }}$ | $\mathrm{V}_{\mathrm{GND}}-0.3$ to 5.5 | V |
| Supply voltage on pins: VCCINOUT, VCCDIG | $\mathrm{V}_{\mathrm{CC}}$ | $\mathrm{V}_{\mathrm{GND}}-0.3$ to 3.6 | V |
| Supply voltage on pins: VCC2IN, VCC2RF, VCC2VCO | $\mathrm{V}_{\mathrm{CC} 2}$ | $\mathrm{V}_{\mathrm{GND}}-0.3$ to 2.7 | V |
| Voltage allowed on each pin (except RFOUT and digital pins) | - | $\mathrm{V}_{\mathrm{GND}}{ }^{-0.3}$ to $\mathrm{V}_{\mathrm{CC} 2}$ | V |
| Voltage allowed on pin: RFOUT | $\mathrm{V}_{\text {CCPA }}$ | $\mathrm{V}_{\mathrm{GND}}-0.3$ to $\mathrm{V}_{\mathrm{CC}}+2$ | V |
| Voltage allowed on digital pins: SEB, SCLK, MISO, MOSI, CONFB, DATACLK, RSSIC, STROBE | $\mathrm{V}_{\text {CCIO }}$ | $\mathrm{V}_{\mathrm{GND}}-0.3$ to $\mathrm{V}_{\mathrm{CC}}+0.3$ | V |
| ESD HBM voltage capability on each pin ${ }^{1}$ | - | $\pm 2000$ | V |
| ESD MM voltage capability on each pin ${ }^{2}$ | - | $\pm 200$ | V |
| Solder heat resistance test (10 s) | - | 260 | ${ }^{\circ} \mathrm{C}$ |
| Storage temperature | $\mathrm{T}_{\text {S }}$ | -65 to +150 | ${ }^{\circ} \mathrm{C}$ |
| Junction temperature | $\mathrm{T}_{J}$ | 150 | ${ }^{\circ} \mathrm{C}$ |

NOTES:
Human body model, AEC-Q100-002 rev. C.
2 Machine model, AEC-Q100-003 rev. C.

## Power Supply

## 5 Power Supply

Table 3. Supply Voltage Range Versus Ambient Temperature

| Parameter | Symbol | Temperature Range $^{\mathbf{1}}$ |  | Unit |
| :--- | :---: | :---: | :---: | :---: |
|  |  | $\mathbf{- 4 0}^{\circ} \mathbf{C}$ to $\mathbf{+ 8 5}^{\circ} \mathbf{C}$ | $\mathbf{- 2 0}^{\circ} \mathbf{C}$ to $\mathbf{+ 8 5}^{\circ} \mathbf{C}$ |  |
| Supply voltage on VCCIN, VCCINOUT, VCCDIG for 3 V operation | $\mathrm{V}_{\mathrm{CC} 3 \mathrm{~V}}$ | 2.7 to 3.6 | 2.1 to 3.6 | V |
| Supply voltage on VCCIN for 5 V operation | $\mathrm{V}_{\mathrm{CC} 5 \mathrm{~V}}$ | 4.5 to 5.5 | 4.5 to 5.5 | V |
| Supply voltage on VCCPA for 3 V or 5 V operation | $\mathrm{V}_{\mathrm{CCPA}}$ | 3.0 to 3.6 | 3.0 to 3.6 | V |

NOTES:
$1-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ : MC33696FCE/FJE.
$-20^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ : MC33696FCAE/FJAE.
The circuit can be supplied from a 3 V voltage regulator or battery cell by connecting VCCIN, VCCINOUT, and VCCDIG (See Figure 43 or Figure 44). It is also possible to use a 5 V power supply connected to VCCIN; in this case VCCINOUT and VCCDIG should not be connected to VCCIN (See Figure 45 or Figure 46).

The RFOUT pin cannot be biased with a voltage higher than 3.6 V . For 5 V operation, biasing voltage is available on VCCINOUT.

An on-chip low drop-out voltage regulator supplies the RF and analog modules (except the strobe oscillator and the low voltage detector, which are directly supplied from VCCINOUT). This voltage regulator is supplied from pin VCCINOUT and its output is connected to VCC2OUT. An external capacitor ( $\mathrm{C} 8=100 \mathrm{nF}$ ) must be inserted between VCC2OUT and GND for stabilization and decoupling. The analog and RF modules must be supplied by VCC2 by externally wiring VCC2OUT to VCC2IN, VCC2RF, and VCC2VCO.
A second voltage regulator supplies the digital part. This regulator is powered from pin VCCDIG and its output is connected to VCCDIG2. An external capacitor ( $\mathrm{C} 10=100 \mathrm{nF}$ ) must be inserted between VCCDIG2 and GNDDIG, for decoupling. The supply voltage VCCDIG2 is equal to 1.6 V . In standby mode, this voltage regulator goes into an ultra-low-power mode, but VCCDIG2 $=0.7 \times \mathrm{V}_{\text {CCDIG }}$.
This enables the internal registers to be supplied, allowing configuration data to be saved.

## 6 Supply Voltage Monitoring and Reset

At power-on, an internal reset signal (Power-on Reset, POR) is generated when supply voltage is around 1.3 V. All registers are reset.

When the LVDE bit is set, the low-voltage detection module is enabled. This block compares the supply voltage on VCCINOUT with a reference level of about 1.8 V . If the voltage on VCCINOUT drops below 1.8 V , status bit LVDS is set. The information in status bit LVDS is latched and reset after a read access.

## NOTE

If $\operatorname{LVDE}=1$, the LVD module remains enabled. The circuit cannot be put in standby mode, but remains in LVD mode with a higher quiescent current, due to the monitoring circuitry. LVD function is not accurate in standby mode.

## 7 Receiver Functional Description

The receiver is based on a superheterodyne architecture with an intermediate frequency IF (see Figure 1). Its input is connected to the RFIN pin. Frequency down conversion is done by a high-side injection I/Q mixer driven by the frequency synthesizer. An integrated poly-phase filter performs rejection of the image frequency.

The low intermediate frequency allows integration of the IF filter providing the selectivity. The IF Filter center frequency is tuned by automatic frequency control (AFC) referenced to the crystal oscillator frequency.
Sensitivity is met by an overall amplification of approximately 96 dB , distributed over the reception chain, comprising low-noise amplifier (LNA), mixer, post-mixer amplifier, and IF amplifier. Automatic gain control (AGC), on the LNA and the IF amplifier, maintains linearity and prevents internal saturation. Sensitivity can be reduced using four programmable steps on the LNA gain.

Amplitude demodulation is achieved by peak detection. Frequency demodulation is achieved in two steps: the IF amplifier AGC is disabled and acts as an amplitude limiter; a filter performs a frequency-to-voltage conversion. The resulting signal is then amplitude demodulated in the same way as in the case of amplitude modulation with an adaptive voltage reference.

A low-pass filter improves the signal-to-noise ratio of demodulated data. A data slicer compares demodulated data with a fixed or adaptive voltage reference and provides digital level data.

This digital data is available if the integrated data manager is not used.
If used, the data manager performs clock recovery and decoding of Manchester coded data. Data and clock are then available on the serial peripheral interface (SPI). The configuration sets the data rate range managed by the data manager and the bandwidth of the low-pass filter.

An internal low-frequency oscillator can be used as a strobe oscillator to perform an automatic wakeup sequence.

It is also possible to define two different configurations for the receiver (frequency, data rate, data manager, modulation, etc.) that are automatically loaded during wakeup or under MCU control.
If the PLL goes out of lock, received data is ignored.

## 8 Transmitter Functional Description

The single-ended power amplifier is connected to the RFOUT pin.
In the case of amplitude modulation, coded data sent by the microcontroller unit (MCU) are used for on/off keying (OOK) the RF carrier. Rise and fall times of the RF transmission are controlled to minimize spurious emission.
In the case of frequency modulation, coded data sent by the MCU are used for frequency shift keying (FSK) the RF carrier.

RF output power can be reduced using four programmable steps.
Out-of-lock detection prevents any out-of-band emission, by stopping the transmission.
The logic output SWITCH enables control of an external RF switch for isolating the two RF pins. Its output toggles when the circuit changes from receive to transmit, and vice versa.

This signal can also be used to control an external power amplifier or LNA, or to indicate to the MCU the current state of the MC33696 (RX or TX).

## 9 Frequency Planning

### 9.1 Clock Generator

All clocks running in the circuit are derived from the reference frequency provided by the crystal oscillator (frequency $f_{\text {ref }}$, period $t_{\text {ref }}$ ). The crystal frequency is chosen in relation to the band in which the MC33696 has to operate. Table 4 shows the value of the CF bits.

Table 4. Crystal Frequency and CF Values Versus Frequency Band

| RF <br> Frequency (MHz) | CF1 | CFO | LOF1 | LOF0 | $F_{\text {REF }}$ (Crystal Frequency) (MHz) | $\mathrm{F}_{\mathrm{IF}}(\mathrm{IF}$ <br> Frequency) (MHz) | Dataclk Divider | $\begin{gathered} F_{\text {dataclk }} \\ (k H z) \end{gathered}$ | Digclk Divider | $\begin{gathered} \mathrm{F}_{\text {digclk }} \\ (\mathrm{kHz}) \end{gathered}$ | $\mathrm{T}_{\text {digclk }}$ ( $\mu \mathrm{s}$ ) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 304 | 0 | 0 | 0 | 0 | 16.96745 | 1.414 | 60 | 282.791 | 30 | 565.582 | 1.77 |
| 315 | 0 | 0 | 1 | 0 | 17.58140 | 1.465 | 60 | 293.023 | 30 | 586.047 | 1.71 |
| 426 | 0 | 1 | 1 | 0 | 23.74913 | 1.484 | 80 | 296.864 | 40 | 593.728 | 1.68 |
| 433.92 | 0 | 1 | 0 | 1 | 24.19066 | 1.512 | 80 | 302.383 | 40 | 604.767 | 1.65 |
| 868.3 | 1 | 1 | 0 | 1 | 24.16139 | 1.510 | 80 | 302.017 | 40 | 604.035 | 1.66 |
| 916.5 | 1 | 1 | 1 | 1 | 25.50261 | 1.594 | 80 | 318.783 | 40 | 637.565 | 1.57 |

### 9.2 Intermediate Frequency

The IF filter is controlled by the crystal oscillator to guarantee the frequency over temperature and voltage range. The IF filter center frequency, FIF, can be computed using the crystal frequency $f_{\text {ref }}$ and the value of the CF bits:

$$
\text { - If CF[0] }=0: \text { FIF }=\mathrm{f}_{\mathrm{ref}} / 9 \times 1.5 / 2
$$

- If CF[0] = $1: \mathrm{FIF}=\mathrm{f}_{\mathrm{ref}} / 12 \times 1.5 / 2$

The cut-off frequency given in the parametric section can be computed by scaling to the FIF.

## Example 1. Cut-off Frequency Computation

Compute the low cut-off frequency of the IF filter for a 16.9683 MHz crystal oscillator. For this reference frequency, FIF $=1.414 \mathrm{MHz}$.
So, the $1.387 \mathrm{MHz}^{1}$ low cut-off frequency specified for a 1.5 MHz IF frequency becomes $1.387 \times 1.414 / 1.5=1.307 \mathrm{MHz}$.

### 9.3 Frequency Synthesizer Description

The frequency synthesizer consists of a local oscillator (LO) driven by a fractional N phase locked loop (PLL).

The LO is an integrated LC voltage controlled oscillator (VCO) operating at twice the RF frequency (for the 868 MHz frequency band) or four times the RF frequency (for the 434 MHz and 315 MHz frequency bands). This allows the I/Q signals driving the mixer to be generated by division.

The fractional divider offers high flexibility in the frequency generation for:

- Switching between transmit and receive modes.
- Achieving frequency modulation in FSK modulation transmission.
- Performing multi-channel links.
- Trimming the RF carrier.

Frequencies are controlled by means of registers. To allow for user preference, two programming access methods are offered (see Section 18.3, "Frequency Registers").

- In friendly access, all frequencies are computed internally from the contents of the carrier frequency and deviation frequency registers.
- In direct access, the user programs direct all three frequency registers.


## 10 MCU Interface

The MC33696 and the MCU communicate via a serial peripheral interface (SPI). According to the selected mode, the MC33696 or the MCU manages the data transfer. The MC33696's digital interface can be used as a standard SPI (master/slave) or as a simple interface (SPI deselected). In the following case, the interface's pins are used as standard I/O pins. However, the MCU has the highest priority, as it can control the MC33696 by setting CONFB pin to the low level. During an SPI access, the STROBE pin must remain at high level to prevent the MC33696 from entering standby mode.
The interface is operated by six I/O pins.

- CONFB - Configuration control input

The configuration mode is reached by setting CONFB to low level.

[^0]- STROBE - Wakeup control input

The STROBE pin controls the ON/OFF sequence of the MC33696. When STROBE is set to low level, the receiver is off-when STROBE is set to high level, the receiver is on. The current consumption in receive mode can be reduced by strobing the receiver. The periodic wakeup can be done by MCU only or by an internal oscillator thanks to an external capacitor (strobe oscillator must be previously enabled by setting SOE bit to 1 ). Refer to Section 12.3 , "Receiver On/Off Control," for more details.

- SEB - Serial interface enable control input

When SEB is set high, pins SCLK, MOSI, and MISO are set to high impedance, and the SPI bus is disabled. When SEB is set low, SPI bus is enabled. This allows individual selection in a multiple device system, where all devices are connected via the same bus. The rest of the circuit remains in the current state, enabling fast recovery times, but the power amplifier is disabled to prevent any uncontrolled RF transmission.
If the MCU shares the SPI access with the MC33696 only, SEB control by the MCU is optional. If not used, it could be hardwired to 0 .

- SCLK - Serial clock input/output

Synchronizes data movement in and out of the device through its MOSI and MISO lines. The master and slave devices can exchange a byte of information during a sequence of eight clock cycles. Since SCLK is generated by the master device, this line is an input on the slave device.

- MOSI — Master output slave input/output

In configuration mode, MOSI is an input.
In transmission mode, MOSI is an input and receives encoded data from MCU.
In receive mode, MOSI is an output. Received data is sent on MOSI (see Table 5).
Transmits bytes when master, and receives bytes when slave, with the most significant bit first.
When no data are output, SCLK and MOSI force a low level.

- MISO - Master input/slave output

In configuration mode only, data read from registers is sent to the MCU with the MSB first. There is no master function. Data are valid on falling edges of SCLK. This means that the clock phase and polarity control bits of the microcontroller SPI have to be CPOL $=0$ and CPHA $=1$ (using Freescale acronyms).
Table 5 summarizes the serial digital interface feature versus the selected mode.
Table 5. Serial Digital Interface Feature versus Selected Mode

| Selected Mode |  | MC33696 Digital Interface Use |
| :--- | :--- | :--- |
| Configuration |  | SPI slave, data received on MOSI, SCLK from MCU, MISO is output (SEB=0) |
| Transmit | SPI deselected, MOSI receives encoded data from MCU (SEB $=0)$ |  |
| Receive | DME $=1$ | SPI master, data sent on MOSI with clock on SCLK (SEB=0) |
|  | DME $=0$ | SPI deselected, received data are directly sent to MOSI (SEB=0) |
| Standby / LVD |  | SPI deselected, all I/O are high impedance (SEB $=1$ ) |

Refer to Section 11, "State Machine," and to Figure 2 for more details about all the conditions that must be complied with in order to change between two selected modes.
The data transfer protocol for each mode is described in the following section.

## 11 State Machine

This section describes how the MC33696 controller executes sequences of operations, relative to the selected mode. The controller is a finite state machine, clocked at $\mathrm{T}_{\text {digclk }}$. An overview is presented in Figure 2 (note that some branches refer to other diagrams that provide more detailed information).
There are four different modes: configuration, transmit, receive, and standby/LVD. Each mode is exclusive and can be entered in different ways, as follows.

- External signal: CONFB for configuration mode
- External signal and configuration bits: CONFB, STROBE, TRXE, and/or MODE for all other modes
- External signal and internal conditions: see Figure 3 and Figure 12 for information on how to enter standby/LVD mode

After a Power-on Reset (POR), the circuit is in standby mode (see Figure 2) and the configuration register contents are set to the reset value.
At any time, a low level applied to CONFB forces the finite state machine into configuration mode, whatever the current state. This is not always shown in state diagrams, but must always be considered. Refer to (Section 16, "Power-On Reset and MC33696 Startup") for timing sequence between standy mode and configuration mode.

## State Machine



Figure 2. State Machine Overview

## 12 Receive Mode

The receiver is either waiting for an RF transmission or is receiving one. Two different processes are possible, as determined by the values of the DME bit. The transmitter part is kept off. A state diagram describes the sequence of operations in each case.

## NOTE

If the STROBE pin is tied to a high level before switching to receive mode, the receiver does not go through an off or standby state.

### 12.1 Data Manager Disabled (DME=0)

Data manager disabled means that the SPI is deselected and raw data is sent directly on the MOSI line, while SCLK remains at low level.

Two different processes are possible, as determined by the values of the SOE bit.

### 12.1.1 Data Manager Disabled and Strobe Pin Control

Raw received data is sent directly on the MOSI line. Figure 3 shows the state diagram.


Figure 3. Receive Mode, $\mathrm{DME}=0, \mathrm{SOE}=0$

- State 5:

The receiver is in standby/LVD mode. For further information, see Section 14, "Standby: LVD Mode." A high level applied to STROBE forces the circuit to state 5 b.

- State 5b:

The receiver is kept on by the STROBE pin. Raw data is output on the MOSI line.
For all states: At any time, a low level applied to CONFB forces the state machine to state 1, configuration mode.

### 12.1.2 Data Manager Disabled and Strobe Oscillator Enabled

Raw received data is sent directly on the MOSI line. Figure 4 shows the state diagram.


Figure 4. Receive Mode, DME $=0, S O E=1$

- State 0 :

The receiver is off, but the strobe oscillator and the off counter are running. Forcing the STROBE pin low freezes the strobe oscillator and maintains the system in this state.

- State 0b:

If STROBE pin is set to high level or the off counter reaches the ROFF value, the receiver is on. Raw data is output on the MOSI line.

For all states: At any time, a low level applied to CONFB forces the state machine to state 1, configuration mode.

### 12.2 Data Manager Enabled (DME=1)

The data manager is enabled. The SPI is master. The MC33696 sends the recovered clock on SCLK and the received data on the MOSI line. Data is valid on falling edges of SCLK.

If an even number of bytes is received, the data manager may add an extra byte. The content of this extra byte is random. If the data received do not fill an even number of bytes, the data manager will fill the last byte randomly. Figure 5 shows a typical transfer.


Figure 5. Typical Transfer in Receive mode with Data Manager

### 12.2.1 Data Manager Functions

In receive mode, Manchester coded data can be processed internally by the data manager. After decoding, the data is available on the digital interface, in SPI format. This minimizes the load on the MCU.
The data manager, when enabled ( $\mathrm{DME}=1$ ), has five purposes:

- First ID detection: the received data are compared with the identifier stored in the ID register.
- Then the HEADER recognition: the received data is compared with the data stored in the HEADER register.
- Clock recovery: the clock is recovered during reception of the preamble and is computed from the shortest received pulse. While this signal is being received, the recovered clock is constantly updated to the data rate of the incoming signal.
- Output data and recovered clock on digital interface: see Figure 5.
- End-of-message detection: an EOM consists of two consecutive NRZ ones or zeroes.

Table 6 details some MC33696 features versus DME values.
Table 6. the MC33696 Features versus DME

| DME | Digital Interface Use | Data Format | Output |
| :---: | :---: | :---: | :---: |
| 0 | SPI deselected, received data <br> are directly sent to MOSI <br> when CONFB $=1$ | Bit stream <br> No clock | MOSI <br> - |
| 1 | SPI master, data sent on <br> MOSI with clock on SCLK <br> when CONFB $=1$ | Data bytes <br> Recovered clock | MOSI <br> SCLK |

### 12.2.2 Manchester Coding Description

The MC33696 data manager is able to decode Manchester-coded messages. For other codings, the data manager should be disabled ( $\mathrm{DME}=0$ ) for raw data to be available on MOSI.

## Receive Mode

DME $=0$ : The data manager is disabled. The SPI is deselected. Raw data is sent directly on the MOSI line, while SCLK remains at the low level.

Manchester coding is defined as follows: data is sent during the first half-bit; and the complement of the data is sent during the second half-bit. The signal average value is constant.


Figure 6. Example of Manchester Coding
Clock recovery can be extracted from the data stream itself. To achieve correct clock recovery, Manchester-coded data must have a duty cycle between $47 \%$ and $53 \%$.

### 12.2.3 Frame Format

A complete telegram includes the following sequences: a preamble, an identifier (ID), a header, the message, and an end-of-message (EOM).

## PREAMBLE ID ID ID ID HEADER DATA ............ EOM

Figure 7. Example of Frame Format
These bit sequences are described below.

### 12.2.3.1 Preamble

A preamble is required before the first ID detected. It enables:

- In the case of OOK modulation, the AGC to settle, and the data slicer reference voltage to settle if DSREF = 1
- In the case of FSK modulation, the data slicer reference voltage to settle
- The data manager to start clock recovery

No preamble is needed in case of several IDs are sent as shown in Figure 8. The ID field must be greater than two IDs. The first ID will have the same function as the preamble, and the second ID will have the same function as the single ID.


Figure 8. Example of Frame with Several IDs, No Preamble Needed
For both cases, the preamble content must be defined carefully, to ensure that it will not be decoded as the ID or the header. Figure 9 defines the different preamble in OOK and FSK modulation.


Figure 9. Preamble Definition

### 12.2.3.2 ID

When clock recovery is done, the data manager verifies if an ID is received. The ID is used to identify a useful frame to receive. It is also necessary, when the receiver is strobed, to detect an ID in order to stay in run mode and not miss the frame.

The ID allows selection of the correct device in an RF transmission, as the content has been loaded previously in the ID register. Its length is variable, defined by the IDL[1:0] bits. The complement of the ID is also recognized as the identifier.
It is possible to build a tone to form the detection sequence by programming the ID register with a full sequence of ones or zeroes.

Once the ID is detected, a HEADER will be searched to detect the beginning of the useful data to send on the SPI port.
See Section 12.2.4, "State Machine in Receive Mode When DME=1" for more details when ID is not detected when $\mathrm{SOE}=1$ or $\mathrm{SOE}=0$.

## Receive Mode

### 12.2.3.3 HEADER

The HEADER defines the beginning of the message, as it is compared with the HEADER register. Its length is variable, defined by the HDL[1:0] bits. The complement of the header is also recognized as the header-in this case, output data is complemented. The header and its complement should not be part of the ID.

The ID and the header are sent at the same data rate as data.

### 12.2.3.4 Data and EOM

The data must follow the header, with no delay.
The message is completed with an end-of-message (EOM), consisting of two consecutive NRZ ones or zeroes (i.e., a Manchester code violation). Even in the case of FSK modulation, data must conclude with an EOM, and not simply by stopping the RF transmission.

### 12.2.4 State Machine in Receive Mode When DME=1

When the strobe oscillator is enabled ( $\mathrm{SOE}=1$ ), the receiver is continuously cycling on/off. The ID must be recognized for the receiver to stay on. Consequently, the transmitted ID burst must be long enough to include two consecutive receiver-on cycles.

When the strobe oscillator is not enabled ( $\mathrm{SOE}=0$ ), these timing constraints must be respected by the external control applied to pin STROBE.

Figure 11 shows the correct detection of an ID when STROBE is controled internally using the strobe oscillator ( $\mathrm{SOE}=1$ ) or externally by the $\mathrm{MCU}(\mathrm{SOE}=0)$.


Figure 10. Complete Transmission with ID Detection
Two different processes are possible, as determined by the values of the SOE bit.

### 12.2.4.1 Data Manager Enabled and Strobe Oscillator Enabled

Figure 11 shows the state diagram when the data manager and the strobe oscillator are enabled. In this configuration, the receiver is controlled internally by the strobe oscillator. However, external control via the STROBE pin is still possible, and overrides the strobe oscillator command.

- State 10 :

The receiver is off, but the strobe oscillator and the off counter are running. Forcing STROBE pin to the low level maintains the system in this state.

- State 11:

The receiver is waiting for a valid ID. If an ID, or its complement, is detected, the state machine advances to state 12; otherwise, the circuit goes back to state 10 at the end of the RON time, if STROBE $\neq 1$.

- State 12:

An ID or its complement has been detected. The data manager is now waiting for a header or its complement. If neither a header, nor its complement, has been received before a time-out of 256 bits at data rate, the system returns to state 10 .

- State 13:

A header, or its complement, has been received. Data and clock signals are output on the SPI port until EOM indicates the end of the data sequence. If the complement of the header has been received, output data are complemented also.
For all states: At any time, a low level applied to STROBE forces the circuit to state 10, and a low level applied on CONFB forces the state machine to state 1, configuration mode.
When an EOM occurs before the current byte is fully shifted out, dummy bits are inserted until the number of shifted bits is a multiple of 8 .

## Receive Mode



Figure 11. Receive Mode, DME $=1, \mathrm{SOE}=1$

### 12.2.4.2 Data Manager Enabled and Receiver Controlled by Strobe Pin

Figure 12 shows the state diagram when the data manager is enabled and the strobe oscillator is disabled. In this configuration, the receiver is controlled only externally by the MCU.


Figure 12. Receive Mode, $D M E=1, S O E=0$

- State 20:

The receiver is in standby/LVD mode. For further information, see Section 14, "Standby: LVD Mode." A high level applied to STROBE forces the circuit to state 21.

- State 21:

The circuit is waiting for a valid ID. If an ID, or its complement, is detected, the state machine advances to state 22 ; if not, the state machine will remain in state 21 , as long as STROBE is high.

- State 22:

If a header, or its complement, is detected, the state machine advances to state 23 . If not, the state machine will remain in state 22 , as long as STROBE is high.

- State 23:

A header or its complement has been received; data and clock signals are output on the SPI port until an EOM indicates the end of the data sequence. If the complement of the header has been

## Receive Mode

received, output data are complemented also. When an EOM occurs before the current byte is fully shifted out, dummy bits are inserted until the number of shifted bits is a multiple of 8 .
For all states: At any time, a low level applied to STROBE puts the circuit into state 20, and a low level applied to CONFB forces the state machine to state 1, configuration mode.

### 12.2.4.3 Timing Definition

As shown in Figure 13, a settling time is required when entering the on state.


Figure 13. Receiver Usable Window
The goal for the receiver is to recognize at least one ID during Ton time. Many IDs are transmitted during that time.

During Ton, the receiver should be able to detect an ID, but as receiver and transmitter are not synchronized, an ID may already be transmitted when Ton time begins. That is the reason why Ton should be sized to receive two IDs: to be sure to recognize one, no matter what the time difference between beginning of transmission of the ID and beginning of run time for the receiver.

Ton should also include the setting time of the receiver. Setting time is composed of the crystal oscillator wakeup time ${ }^{1}$, the PLL lock time ${ }^{2}$, and setup of all analog parameters ${ }^{3}$ (AGC and demodulator need some time to settle).

Toff should be sized to allow the positioning of an on state during the transmission of the ID field.
During the setting time, no reception is possible.

### 12.3 Receiver On/Off Control

In receive mode, on/off sequencing can be controlled internally using the strobe oscillator, or managed externally by the MCU through the input pin STROBE.
If the strobe oscillator is selected $(\mathrm{SOE}=1)$ :

- Off time is clocked by the strobe oscillator
- On time is clocked by the crystal oscillator, enabling accurate control of the on time, and therefore of the current consumption of the whole system

[^1]Each time is defined with the associated value found in the RXONOFF register.

- On time $=$ RON[3:0] $\times 512 \times \mathrm{T}_{\text {digclk }}$ (see Table 19; begins after the crystal oscillator has started)
- Off time $=$ receiver off time $=\mathrm{N} \times \mathrm{T}_{\text {Strobe }}+\mathrm{MIN}\left(\mathrm{T}_{\text {Strobe }} / 2\right.$, receiver on time $)$, with N decoded from ROFF[2:0] (see Table 20)
The strobe oscillator is a relaxation oscillator in which an external capacitor C13 is charged by an internal current source (see Figure 46). When the threshold is reached, C13 is discharged and the cycle restarts. The strobe frequency is $\mathrm{F}_{\text {Strobe }}=1 / \mathrm{T}_{\text {Strobe }}$ with $\mathrm{T}_{\text {Strobe }}=10^{6} \times \mathrm{C} 13$.
In receive mode, setting the STROBE pin to $\mathrm{V}_{\mathrm{CCIO}}$ at any time forces the circuit on. As $\mathrm{V}_{\mathrm{CCIO}}$ is above the oscillator threshold voltage, the condition on which the STROBE pin is set to $\mathrm{V}_{\text {CCIO }}$ is detected internally, and the oscillator pulldown circuitry is disabled. This limits the current consumption. After the STROBE pin is forced to high level, the external driver should pass via a " 0 " state to discharge the capacitor before going to high impedance state (otherwise, the on time would last a long time after the driver release).
When the strobe oscillator is running (i.e., during an off time), forcing the STROBE pin to $\mathrm{V}_{\mathrm{GND}}$ stops the strobe clock, and therefore keeps the circuit off.

Figure 14 shows the associated timings.


Figure 14. Receiver On/Off Sequence

### 12.4 Received Signal Strength Indicator (RSSI)

### 12.4.1 Module Description

In receive mode, a received signal strength indicator can be activated by setting bit RSSIE.
The input signal is measured at two different points in the receiver chain by two different means, as follows.

- At the IF filter output, a progressive compression logarithmic amplifier measures the input signal, ranging from the sensitivity level up to -50 dBm .


## Receive Mode

- At the LNA output, the LNA AGC control voltage is used to monitor input signals in the range -50 dBm to -20 dBm .

Therefore, the logarithmic amplifier provides information relative to the in-band signal, whereas the LNA AGC voltage senses the input signal over a wider band.

The RSSI information given by the logarithmic amplifier is available in:

- Analog form on pin RSSIOUT
- Digital form in the four least significant bits of the status register RSSI

The information from the LNA AGC is available in digital form in the four most significant bits of status register RSSI.

The whole content of status register RSSI provides $2 ¥ 4$ bits of RSSI information about the incoming signal (see Section 18.6, "RSSI Register").

Figure 15 shows a simplified block diagram of the RSSI function.
The quasi peak detector (D1, R1, C1) has a charge time of about $20 \mu$ s to avoid sensitivity to spikes.
R2 controls the decay time constant of about 5 ms to allow efficient smoothing of the OOK modulated signal at low data rates. This time constant is useful in continuous mode when S 2 is permanently closed.

To allow high-speed RSSI updating in peak pulse measurement, a discharge circuit (S1) is required to reset the measured voltage and to allow new peak detection.


Figure 15. RSSI Simplified Block Diagram
S2 is used to sample the RSSI voltage to allow peak pulse measurement ( S 2 used as sample and hold), or to allow continuous transparent measurement ( S 2 continuously closed).

The 4-bit analog-to-digital convertor (ADC) is based on a flash architecture. The conversion time is $16 \times \mathrm{T}_{\text {diglck }}$. As a single convertor is used for the two analog signals, the RSSI register content is updated on a $32 \times \mathrm{T}_{\text {digclk }}$ timebase.
If RSSIE is reset, the whole RSSI module is switched off, reducing the current consumption. The output buffer connected to RSSIOUT is set to high impedance.

### 12.4.2 Operation

Two modes of operation are available: sample mode and continuous mode.

### 12.4.2.1 Sample Mode

Sample mode allows the peak power of a specific pulse in an incoming frame to be measured.
The quasi peak detector is reset by closing S1. After $7 \times \mathrm{T}_{\text {digclk }}, \mathrm{S} 1$ is released. S2 is closed when RSSIC is set high. On the falling edge of RSSIC, S2 is opened. The voltage on RSSIOUT is sampled and held. The last RSSI conversion results are stored in the RSSI register and no further conversion is done.
The RSSI register is updated every $32 \times \mathrm{T}_{\text {digclk }}$. Therefore, the minimum duration of the high pulse on RSSIC is $32 \times \mathrm{T}_{\text {digclk }}$.


Figure 16. RSSI Operation in Sample Mode

### 12.4.2.2 Continuous Mode

Continuous mode is used to make a peak measurement on an incoming frame, without having to select a specific pulse to be measured.

The quasi peak detector is reset by closing S1. After $7 \times \mathrm{T}_{\text {digclk }}$, S 1 is opened. S 2 is closed when RSSIC is set high. As long as RSSIC is kept high, S2 is closed, and RSSIOUT follows the peak value with a decay time constant of 5 ms .

The ADC runs continuously, and continually updates the RSSI register. Thus, reading this register gives the most recent conversion value, prior to the register being read. The minimum duration of the high pulse on CONFB is $32 \times \mathrm{T}_{\text {digclk }}$.

## Transmit Mode



Figure 17. RSSI Operation in Continuous Mode

## 13 Transmit Mode

### 13.1 Description

The SPI is deselected. The MC33696 receives the message to transmit on the MOSI line (see Figure 18).


Figure 18. Transfer in Transmit Mode
In OOK modulation (MODU=0), modulation is performed by switching the RF output stage on and off.
MOSI $=0$ : output stage off
MOSI $=1$ : output stage on
In FSK modulation (MODU = 1), modulation is performed by switching the RF carrier between two values.

MOSI $=0: \mathrm{f}_{\text {carrier0 }}$ corresponding to a logical 0
MOSI $=1: \mathrm{f}_{\text {carrier } 1}$ corresponding to a logical 1

See the FRM bit description (Figure 26) and Section 18.3, "Frequency Registers," for more details about setting carrier frequencies.

See Section 10, "MCU Interface," for more details about setting the level on the SEB pin.

### 13.2 State Machine

In transmit mode, the state diagram is reduced to only one state: state 30 . The circuit is either waiting for a digital telegram to send, or is sending one. In this mode, the circuit can be considered as a simple RF physical interface. The information presented on MOSI is sent directly in RF (according to the selected modulation), with no internal processing.
Data transmission is possible only if the PLL is within the lock-in range. Therefore, during transmission, if the PLL switches out of lock-in range, the RF output stage is switched off internally, thereby preventing data from being transmitted in an unwanted band.

## 14 Standby: LVD Mode

The SPI is deselected. CONFB is set to high level and STROBE to low level in order to enter this mode. Nothing is sent and all incoming data are ignored until CONFB and SEB go low to switch back to configuration mode.
Standby/LVD mode allows minimum current consumption to be achieved. Depending upon the value of the LVDE bit, the circuit is in standby mode (state 60) or LVD mode (state 5 and 20).
LVDE $=0$ : The transceiver is in standby; consumption is reduced to leakage current (current state after POR).

LVDE $=1:$ The LVD function is enabled; consumption is in the range of tens of microamperes.
The only way to exit this mode is to go back to configuration mode by applying a low level to CONFB and a high level to STROBE.

## 15 Configuration Mode

### 15.1 Description

This mode is used to write or read the internal registers of the MC33696.
As long as a low level is applied to CONFB and a high level to STROBE (see Figure 2), the MCU is the master node driving the SCLK input, the MOSI line input, and the MISO line output. Whatever the direction, SPI transfers are 8-bit based and always begin with a command byte, which is supplied by the MCU on MOSI. To be considered as a command byte, this byte must come after a falling edge on CONFB. Figure 19 shows the content of the command byte.

|  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Bit Name | N1 | N0 | A4 | A3 | A2 | A1 | A0 | R/W |

Figure 19. Command Byte
Bits $\mathrm{N}[1: 0]$ specify the number of accessed registers, as defined in Table 7.
Table 7. Number N of Accessed Registers

| $\mathbf{N}[1: 0]$ | Number $\mathbf{N}$ of Accessed Registers |
| :---: | :---: |
| 00 | 1 |
| 01 | 2 |
| 10 | 4 |
| 11 | 8 |

Bits A[4:0] specify the address of the first register to access. This address is then incremented internally by N after each data byte transfer.
R/W specifies the type of operation:

$$
\begin{aligned}
& 0=\text { Read } \\
& 1=\text { Write }
\end{aligned}
$$

Thus, this bit is associated with the presence of information on MOSI (when writing) or MISO (when reading).
Figure 20 and Figure 21 show write and read operations in a typical SPI transfer. In both cases, the SPI is a slave. A received byte is considered internally on the eighth falling edge of SCLK. Consequently, the last received bits, which do not form a complete byte, are lost.

Refer to Section 21.9, "Digital Interface Timing," to view the timing definition for SPI communication.
If several SPI accesses are done, a high and low level is applied to CONFB, and so on. By applying a high level to STROBE, the MC33696 never enters standby mode. If there is no way to configure the level on STROBE, the time interval between two SPI accesses must be less than one digital clock period $\mathrm{T}_{\text {digclk }}$.

## NOTE

A low level applied to CONFB and a high level to STROBE do not affect the configuration register contents.
See Section 10, "MCU Interface," for more details about setting the level on the SEB pin.


Figure 20. Write Operation in Configuration Mode ( $\mathrm{N}[1: 0]=01$ )


Figure 21. Read Operation in Configuration Mode ( $\mathrm{N}[1: 0]=01$ )

### 15.2 State Machine

The configuration mode is selected by the microcontroller unit (MCU) to write to the internal registers (to configure the system) or to read them. In this mode, the SPI is a slave. The analog parts (receiver and transmitter) remain in the state (on, off) they were in prior to entering configuration mode, until a new configuration changes them. In configuration mode, data can be neither sent nor received. As long as a low level is applied to CONFB, the circuit stays in State 1, the only state in this mode.

Figure 22 describe the valid sequence for enabling a correct transition from Standby/LVD mode to configuration mode. SPI startup time corresponds to the addition of the crystal oscillator lock time (parameter 5.10) and the PLL lock time (parameter 5.9).

## Power-On Reset and MC33696 Startup



Figure 22. Valid Sequence from Standby/LVD Mode to Configuration Mode
Figure 23 describes the sequence for enabling a correct transition from receive mode to configuration mode.

1. MC33696 is in receive mode.
2. CONFB is forced to low level during one digital period $\mathrm{T}_{\text {digclk }}$ in order to reset the state machine only.
3. CONFB is set to high level during the time length of an ID.


Figure 23. Valid Sequence from Receive Mode to Configuration Mode

## 16 Power-On Reset and MC33696 Startup

The startup sequence can be divided into three stages as defined in Figure 24:

1. The power supply is applied to the MC33696 and an external pullup resistor on CONFB is required to enter standby mode. SEB can be either set to low level if the SPI access is not shared with another external MCU, or connected to an external pullup resistor (see Section 10, "MCU Interface").
During this stage and during the ramp-up of the power supply, signals from the MCU connected to the MC33696 are undefined. That is why the MC33696 must start in standby mode.

## NOTE

Along with the ramp-up of power supply, one of these two conditions must be complied with:

- Power supply of the MC33696 must rise in 1 ms from 0 V to 3 V .
- The level on STROBE pin is lower than 0.75 V until the power supply reaches 3 V .

Proposed solutions to verify these conditions are :

- If the receiver does not wake periodically and it is only controlled by the STROBE pin (strobe oscillator disable $\mathrm{SOE}=0$ ), an external pulldown resistor on STROBE is required (see Figure 43 for a 3 V application schematic).
- If the receiver wakes periodically (strobe oscillator enable $\mathrm{SOE}=1$ ), the state of the MCU pins must be defined first and then a power supply must be applied to the MC33696. A transistor can be used to control the power supply on the VCCIN pin of the MC33696. This transistor will be driven by an MCU I/O (see Figure 44 for a 3 V application schematic in strobe oscillator mode).

2. A high level is applied on STROBE in order to wake the MC33696 and enter transmit/receive mode. The duration of this state should be greater than the sum of lock time parameter 5.9 and 5.10. Refer to Section 15, "Configuration Mode."
3. CONFB and SEB must be forced to low level to enter configuration mode. Register values are writen into the internal registers of the MC33696. Refer to Section 15, "Configuration Mode," and to Figure 45.


Figure 24. Startup sequence

## 17 Configuration Switching

This feature allows for defining two different configurations using two different banks, and for switching them automatically during wakeup when using a strobe oscillator, or by means of the strobe pin actuation by the MCU. This automatic feature may be used only in receiver mode; however, if one of the register banks is related to a transmitter configuration, it may be accessed directly by programing some bits to define the active bank, thus allowing fast switching between receiver mode and transmitter mode, or between any different possible configurations.

## Configuration Switching

### 17.1 Bit Definition

Two sets of configuration registers are available. They are grouped in two different banks: Bank A and Bank B. Two bits are used to define which bank represents the state of the component.

| Bit Name | Direction | Location |
| :---: | :---: | :---: |
| BANKA | R/W | Bank A |
| BANKB | R/W | Bank B |
| BANKA | BANKB | Actions |
| X | 0 | Bank A is active (TX or RX) |
| 0 | 1 | Bank B is active (TX or RX) |
| 1 | 1 | Bank A and Bank B are active and will be used one after the other (RX only) |

At any time, it is possible to know which is the active bank by reading the status bit BANKS.

| Bit Name | Direction | Location | Comment |
| :---: | :---: | :---: | :--- |
| BANKS | $R$ | $A \& B$ | Bank status: indicates which register bank is active. <br> This bit, available in Bank A and Bank B, returns the same value. |

### 17.1.1 Direct Switch Control

The conditions to enter direct switch control are:

- $\quad$ Strobe pin $=V_{\mathrm{CC}}$
- SOE bit $=0$

By simply writing BANKA and BANKB, the active bank will be defined:

| BANKA | BANKB |  |
| :---: | :---: | :--- |
| $X$ | 0 | Bank $A$ is active (TX or $R X)$ |
| 0 | 1 | Bank $B$ is active (TX or $R X)$ |
| 1 | 1 | Not allowed in direct switch control |

The defined bank is active after exiting the configuration mode, in other words, CONFB line goes high. The direct switch control should be used when:

- One or both banks are in transmitter configuration (MODE $=1$ )
- When the strobe oscillator cannot be used to define the switch timing (for example, not periodic)
- When strobe pin use is not possible (no sleep mode between the two configurations)
- No automatic switching is required and MCU SPI access is possible


### 17.1.2 Strobe Pin Switch Control

The conditions to enter strobe pin switch control are:

- Strobe pin: controlled by MCU I/O port
- SOE bit $=0$

By simply writing BANKA and BANKB, the active banks will be defined.
BANKA BANKB

| X | 0 | Bank $A$ is active (TX or RX ) |
| :--- | :--- | :--- |
| 0 | 1 | Bank B is active (TX or RX) |
| 1 | 1 | Bank $A$ and Bank B are both active, configuration will toggle at each wakeup; |
|  |  | not allowed with MODE $=1$ |

The strobe pin will control the off/on state of the MC33696. The various available sequences are described in the following subsections.

### 17.1.2.1 $B A N K A=X, B A N K B=0$

| State A | OFF | State A | OFF |
| :---: | :---: | :---: | :---: |
| Strobe Pin |  |  |  |

If strobe pin is 1 , configuration is defined by Bank $\mathrm{A}, \mathrm{BANKS}=1$.
If strobe pin is 0 , MC33696 configuration is OFF.
If a message is received during State A, current state remains State A up to end of message.

### 17.1.2.2 $\operatorname{BANKA}=0$, BANKB $=1$

| State B | OFF | State B | OFF |
| :---: | :---: | :---: | :---: |
|  |  |  |  |
| Strobe Pin |  |  |  |

If strobe pin is 1 , configuration is defined by Bank $B, B A N K S=0$.
If strobe pin is 0 , MC33696 configuration is OFF.
If a message is received during State B, current state remains State B up to end of message.

### 17.1.2.3 $B A N K A=1, B A N K B=1$

| State A | OFF | State B | OFF | State A |
| :---: | :---: | :---: | :---: | :---: |
| Strobe Pin |  |  |  |  |
| Banks Bit |  |  |  |  |

If strobe pin is 1 , configuration is defined by BANKS. BANKS is toggled at each falling edge of the strobe pin.
If strobe pin is $0, \mathrm{MC} 33696$ configuration is OFF.
If a message is received during state $A$ or state $B$, current state remains the same up to end of message.
If a read or write access is done using SPI, the next sequence will begin with state A whatever was the active state before SPI access by MCU.

### 17.1.3 Strobe Oscillator Switch Control

The conditions to enter strobe oscillator switch control are:

- Strobe pin connected to an external capacitor to define timing (see Section 12.3, "Receiver On/Off Control")
- Strobe pin can also be connected to the MCU I/O port
- SOE bit = 1

By simply writing BANKA and BANKB, the active banks will be defined.

| BANKA | BANKB |  |
| :---: | :---: | :--- |
| X | 0 | Bank $A$ is active $(\mathrm{TX}$ or RX$)$ |
| 0 | 1 | Bank $B$ is active $(T X$ or $R X)$ |
| 1 | 1 | Bank $A$ and Bank $B$ are both active, configuration will toggle at each wakeup; <br> not allowed with MODE $=1$ |

The MCU can override strobe oscillator control by controlling the strobe pin level. If MCU I/O port is in high impedance, the strobe oscillator will control the OFF/ON state of the MC33696. The various available sequences are described in the following subsections.

### 17.1.3.1 $B A N K A=X, B A N K B=0$

| State A | OFF | State A | OFF | State A |
| :---: | :---: | :---: | :---: | :---: |

If strobe pin is 1 , configuration is defined by Bank $\mathrm{A}, \mathrm{BANKS}=1$.
If strobe pin is 0 , MC33696 configuration is OFF.
If a message is received during State A, current state remains State A up to end of message.

### 17.1.3.2 $B A N K A=0, B A N K B=1$

| State B | OFF | State B | OFF | State B |
| :---: | :---: | :---: | :---: | :---: |

If strobe pin is 1 , configuration is defined by Bank $B, B A N K S=0$.
If strobe pin is 0 , MC33696 configuration is OFF.
If a message is received during State B, current state remains State B up to end of message.

### 17.1.3.3 $B A N K A=1$, BANK $B=1$

| State A | State B | OFF | StateA | StateB | OFF |
| :---: | :---: | :---: | :---: | :---: | :---: |

Banks Bit
$\square$

BANKS toggles at the end of each state A or state B.
If strobe is forced to 1 , configuration is frozen according to BANKS value.
If a read or write access is done using SPI, the next sequence will begin with state $A$ in whatever was the active state before SPI access by MCU.


For all available sequences:

- State A and State B are defined by Bank A and Bank B.
- State A duration, TonA is defined by Bank A RON[3-0].
- State B duration, TonB is defined by Bank B RON[3-0].
- OFF duration, TonB is defined by Bank A ROFF[2-0].
- If strobe pin is 1 , the state is ON and defined by BANKS at that time. It remains this state up to the release of strobe and end of message if a message is being received.
- If a message is being received during State A or B, current state remains State A or B up to end of message.


## Register Description

- If strobe pin is 0 the state is OFF.
- If strobe pin is released from 0 while state is OFF, the initial OFF period is completed.

The change of duration of one state (due to the STROBE pin level or a message being received) has no influence on the timing of the following states (A, B, or OFF).

## 18 Register Description

This section discusses the internal registers, which are composed of two classes of bits.

- Configuration and command bits allow the MC33696 to operate in a suitable configuration.
- Status bits report the current state of the system.

All registers can be accessed by the SPI. These registers are described below.
At power-on, the POR resets all registers to a known value (in the shaded rows in the following tables). This defines the MC33696's default configuration.

### 18.1 Configuration Registers (Description Bank A only)

Figure 25 describes configuration register 1, CONFIG1.

|  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 | $\begin{aligned} & \text { Addr } \\ & \$ 00 \end{aligned}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Bit Name | LOF1 | LOFO | CF1 | CFO | RESET | SL | LVDE | CLKE |  |
| Reset Value | 1 | 0 | 0 | 1 | 0 | 0 | 0 | 1 |  |
| Access | R/W | R/W | R/W | R/W | R/W | R/W | R/W | R/W |  |

Figure 25. CONFIG1 Register
Table 8. LOF[1:0] and CF[1:0] Setting Versus Carrier Frequency

| Carrier Frequency | LOF1 | LOF0 | CF1 | CF0 |
| :---: | :---: | :---: | :---: | :---: |
| 304 MHz | 0 | 0 | 0 | 0 |
| 315 MHz | 1 | 0 | 0 | 0 |
| 426 MHz | 0 | 1 | 0 | 1 |
| 434 MHz | 0 | 1 | 0 | 1 |
| 868 MHz | 0 | 1 | 1 | 1 |
| 915 MHz | 1 | 1 | 1 | 1 |

RESET is a global reset. The bit is cleared internally, after use.
$0=$ no action
$1=$ reset all registers and counters
SL (Switch Level) selects the active level of the SWITCH output pin.

Table 9. Active Level of SWITCH Output Pin

| SL | Transceiver Function | Level on SWITCH |
| :---: | :---: | :---: |
| 0 | Receiving | Low |
|  | Transmitting | High |
| 1 | Transmitting | Low |
|  | Receiving | High |

LVDE (Low Voltage Detection Enable) enables the low voltage detection function.
$0=$ disabled
1 = enabled

## NOTE

This bit is cleared by POR. In the event of a complete loss of the supply voltage, LVD is disabled at power-up, but the information is not lost as the status bit LVDS is set by POR.
CLKE (Clock Enable) controls the DATACLK output buffer.
$0=$ DATACLK remains low
$1=$ DATACLK outputs $\mathrm{F}_{\text {dataclk }}$
Figure 26 describes configuration register 2, CONFIG2.

|  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 | Addr <br> \$01 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Bit Name | DSREF | FRM | MODU | DR1 | DR0 | TRXE | DME | SOE |  |
| Reset Value | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 |  |
| Access | R/W | R/W | R/W | R/W | R/W | R/W | R/W | R/W |  |

Figure 26. CONFIG2 Register
DSREF (Data Slicer Reference) selects the data slicer reference.
$0=$ Fixed reference (cannot be used in FSK)
1 = Adaptive reference (recommended for maximum sensitivity in OOK and FSK)
In the case of FSK modulation (MODU = 1), DSREF must be set.
FRM (Frequency Register Manager) enables either a user friendly access to one frequency register or a direct access to the two frequency registers.
$0=$ The carrier frequency and the FSK deviation are defined by the F register
$1=$ The local oscillator frequency and the two carrier frequencies are defined by two frequency registers, F and FT.
MODU (Modulation) sets the data modulation type.
$0=$ On/Off Keying (OOK) modulation
$1=$ Frequency Shift Keying (FSK) modulation
DR[1:0] (Data Rate) configure the receiver blocks operating in base band.

## Register Description

- Low-pass data filter
- Low-pass average filter generating the data slicer reference, if DSREF is set
- Data manager

Table 10. Base Band Parameter Configuration

| DR1 | DR0 | Data Filter <br> Cut-off Frequency | Average Filter <br> Cut-off Frequency | Data Manager <br> Data Rate Range |
| :---: | :---: | :---: | :---: | :---: |
| 0 | 0 | 6 kHz | 0.5 kHz | $2-2.8 \mathrm{kBd}$ |
| 0 | 1 | 12 kHz | 1 kHz | $4-5.6 \mathrm{kBd}$ |
| 1 | 0 | 24 kHz | 2 kHz | $8-10.6 \mathrm{kBd}$ |
| 1 | 1 | 48 kHz | 4 kHz | $16-22.4 \mathrm{kBd}$ |

If the data manager is disabled, the incoming signal data rate must be lower than or equal to the data manager maximum data rate.

TRXE (Transceiver Enable) enables the whole transceiver. This bit must be set to high level if MCU wakes the MC33696 to enter receive or transmit mode.

0 = standby mode
$1=$ other modes can be activated
DME (Data Manager Enable) enables the data manager.
$0=$ disabled
1 = enabled
SOE (Strobe Oscillator Enable) enables the strobe oscillator.
$0=$ disabled
1 = enabled
Figure 27 describes configuration register 3, CONFIG3.

|  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 | Addr <br> \$02 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Bit Name | AFF1 | AFF0 | OLS | LVDS | ILA1 | ILAO | OLA1 | OLAO |  |
| Reset Value | 0 | 0 | 1 | 1 | 0 | 0 | 0 | 0 |  |
| Access | R/W | R/W | R | R | R/W | R/W | R/W | R/W |  |

Figure 27. CONFIG3 Register
OLS (Out of Lock Status) indicates the current status of the PLL.
$0=$ The PLL is in lock-in range
$1=$ The PLL is out of lock-in range
LVDS (Low Voltage Detection Status) indicates that a low voltage event has occurred when LVDE $=1$. This bit is read-only and is cleared after a read access.
$0=$ No low voltage detected
1 = Low voltage detected
ILA [1:0] (Input Level Attenuation) define the RF input level attenuation.

Table 11. RF Input Level Attenuation

| ILA1 | ILAO | RF Input Level <br> Attenuation | See Parameter <br> Number |
| :---: | :---: | :---: | :---: |
| 0 | 0 | 0 dB | 2.5 |
| 0 | 1 | 8 dB | 2.6 |
| 1 | 0 | 16 dB | 2.7 |
| 1 | 1 | 30 dB | 2.8 |

Values in Table 11 assume the LNA gain is not reduced by the AGC.
OLA [1:0] (Output Level Attenuation) define the RF output level attenuation.
Table 12. RF Output Level Attenuation

| OLA1 | OLA0 | RF Output Level <br> Attenuation | See Parameter <br> Number |
| :---: | :---: | :---: | :---: |
| 0 | 0 | 0 dB | 4.2 |
| 0 | 1 | 8 dB | 4.3 |
| 1 | 0 | 16 dB | 4.4 |
| 1 | 1 | 25 dB | 4.5 |

AFF[1:0] (Average Filter Frequency) define the average filter cut-off frequency if the AFFC bit is set.
Table 13. Average Filter Cut-off Frequency

| AFF1 | AFF0 | Average Filter Cut-off <br> Frequency |
| :---: | :---: | :---: |
| 0 | 0 | 0.5 kHz |
| 0 | 1 | 1 kHz |
| 1 | 0 | 2 kHz |
| 1 | 1 | 4 kHz |

If AFFC is reset, the average filter frequency is directly defined by bits DR[1:0], as shown in Table 10.
If AFFC is set, AFF[1:0] allow the overall receiver sensitivity to be improved by reducing the average filter cut-off frequency. The typical preamble duration of three Manchester zeroes or ones at the data rate must then be increased, as shown in Table 14.

Table 14. Minimum Number of Manchester Symbols in Preamble versus DR[1:0] and AFF[1:0]

|  |  | DR[1:0] |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\mathbf{0 0}$ | $\mathbf{0 1}$ | $\mathbf{1 0}$ | $\mathbf{1 1}$ |  |
|  | $\mathbf{0 0}$ | 3 | 6 | 12 | 24 |  |
| AFF[1:0] | $\mathbf{0 1}$ | - | 3 | 6 | 12 |  |
|  | $\mathbf{1 0}$ | - | - | 3 | 6 |  |
|  | $\mathbf{1 1}$ | - | - | - | 3 |  |

### 18.2 Command Register

Figure 28 describes the Command register, COMMAND.

|  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 | Addr <br> $\$ 03$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Bit Name | AFFC | IFLA | MODE | RSSIE | EDD | RAGC | FAGC | BANKS |  |
| Reset Value | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 1 |  |
| Access | R/W | R/W | R/W | R/W | R/W | R/W | R/W | R |  |

Figure 28. COMMAND Register
AFFC (Average Filter Frequency Control) enables direct control of the average filter cut-off frequency.
$0=$ Average filter cut-off frequency is defined by $\operatorname{DR}[1: 0]$
1 = Average filter cut-off frequency is defined by AFF[1:0]
IFLA (IF Level Attenuation) controls the maximum gain of the IF amplifier in OOK modulation.
$0=$ No effect
1 = Decreases by 20 dB (typical) the maximum gain of the IF amplifier, in OOK modulation only
The reduction in gain can be observed if the IF amplifier AGC system is disabled (by setting RAGC $=1$ ).
MODE selects the mode.
$0=$ Receive mode
1 = Transmit mode
RSSIE (RSSI Enable) enables the RSSI function.
$0=$ Disabled
1 = Enabled
EDD (Envelop Detector Decay) controls the envelop detector decay.
$0=$ Slow decay for minimum ripple
1 = Fast decay
RAGC (Reset Automatic Gain Control) resets both receiver internal AGCs.
$0=$ No action
$1=$ Sets the gain to its maximum value
A first SPI access allows RAGC to be set; a second SPI access is required to reset it.
FAGC (Freeze Automatic Gain Control) freezes both receiver AGC levels.
$0=$ No action
$1=$ Holds the gain at its current value
BANKS indicates which register bank is active. This bit, available in Bank A and Bank B, returns the same value.

$$
\begin{aligned}
& 0=\text { Bank B } \\
& 1=\text { Bank A }
\end{aligned}
$$

### 18.3 Frequency Registers

Figure 29 and Figure 30 define the Frequency registers, F and FT.


Figure 29. F Register


Figure 30. FT Register

## Register Description

How these registers are used is determined by the FRM bit, which is described below.

## FRM = 0 (User Friendly Access)

Whatever type of modulation is used (OOK or FSK), bits F [11:0] define the carrier frequency $\mathrm{F}_{\text {carrier }}$ The local oscillator frequency $\mathrm{F}_{\mathrm{LO}}$ is then set automatically to $\mathrm{F}_{\text {carrier }}+\mathrm{F}_{\mathrm{IF}}$ (with $\mathrm{F}_{\mathrm{IF}}=$ intermediate frequency). In addition,

- in the case of OOK modulation (MODU $=0$ ):
- FSK[3:0], FTA[11:0], and FTB[11:0] are not used.
- in the case of FSK modulation ( $\mathrm{MODU}=1$ ):
- FSK[3:0] sets the frequency deviation Df as defined in Table 15.

Table 15. Frequency Deviation Definition

| $\mathbf{C F}[1: 0]$ | Frequency Deviation $\Delta \mathbf{f}$ |
| :---: | :---: |
| 00,01 | $\mathrm{~F}_{\text {ref }} \times(\mathrm{FSK}[3: 0]+1) / 2048$ |
| 11 | $\mathrm{~F}_{\text {ref }} \times(\mathrm{FSK}[3: 0]+1) / 1024$ |

Table 16 gives a numerical example in the 434 MHz band $(\mathrm{CF}[1: 0]=01)$.
Table 16. Frequency Numerical Example ( 434 MHz Band)

| FSK[3:0] | Frequency Deviation $\Delta \mathbf{f}$ |
| :---: | :---: |
| 0000 | $\pm 12 \mathrm{kHz}$ |
| 0001 | $\pm 24 \mathrm{kHz}$ |
| 0010 | $\pm 36 \mathrm{kHz}$ |
| $\ldots$ | $\ldots$ |
| 1111 | $\pm 192 \mathrm{kHz}$ |

Then, two frequencies are calculated internally, as follows.
$-\mathrm{F}_{\text {carrier } 0}=\mathrm{F}[11: 0]-\Delta \mathrm{f}$ to transmit a logical 0
$-\mathrm{F}_{\text {carrier } 1}=\mathrm{F}[11: 0]+\Delta \mathrm{f}$ to transmit a logical 1
FTA [11:0] and FTB[11:0] are not used

## FRM = 1 (Direct Access)

Whatever type of modulation is used ( OOK or FSK ), $\mathrm{F}[11: 0]$ defines the receiver local oscillator frequency $\mathrm{F}_{\mathrm{LO}}$, and,

- if OOK modulation is used ( $\mathrm{MODU}=0$ ):
- FTA[11:0] define the carrier frequency $\mathrm{F}_{\text {carrier }}$
- FTB[11:0] are not used
- if FSK modulation is used ( $\mathrm{MODU}=1$ ):
- FTA[11:0] define the carrier frequency $\mathrm{F}_{\text {carrier0 }}$ to transmit a logical 0
- $\mathrm{FTB}\left[11: 0\right.$ ] define the carrier frequency $\mathrm{F}_{\text {carrier } 1}$ to transmit a logical 1

Table 17 defines the value to be binary coded in the frequency registers $\mathrm{F}[11 ; 0], \mathrm{FTA} / \mathrm{B}[11: 0]$, versus the desired frequency value F (in Hz ).

Table 17. Frequency Register Value versus Frequency Value F

| CF[1:0] | Frequency Register Value |
| :---: | :---: |
| 00,01 | $\left(2 \times \mathrm{F} / \mathrm{F}_{\mathrm{ref}}-35\right) \times 2048$ |
| 11 | $\left(\mathrm{~F} / \mathrm{F}_{\mathrm{ref}}-35\right) \times 2048$ |

Conversely, Table 18 gives the desired frequency F and the frequency resolution versus the value of the frequency registers $\mathrm{F}[11 ; 0]$.

Table 18. Frequency Value F versus Frequency Register Value

| CF[1:0] | Frequency (Hz) | Frequency Resolution (Hz) |
| :---: | :---: | :---: |
| 00,01 | $(35+\mathrm{F}[11 ; 0] / 2048) \times \mathrm{F}_{\text {ref }} / 2$ | $\mathrm{~F}_{\text {ref }} / 4096$ |
| 11 | $(35+\mathrm{F}[11 ; 0] / 2048) \times \mathrm{F}_{\text {ref }}$ | $\mathrm{F}_{\mathrm{ref}} / 2048$ |

### 18.4 Receiver On/Off Duration Register

Figure 31 describes the receiver on/off duration register, RXONOFF.

|  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 | Addr <br> \$09 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Bit Name | BANKA | RON3 | RON2 | RON1 | RON0 | ROFF2 | ROFF1 | ROFF0 |  |
| Reset Value | 0 | 1 | 1 | 1 | 1 | 1 | 1 | 1 |  |
| Access | R/W | R/W | R/W | R/W | R/W | R/W | R/W | R/W |  |

Figure 31. RXONOFF Register
BANKA defines the register bank selected, as described in Section 17, "Configuration Switching."
RON[3:0] (Receiver On) define the receiver on time (after crystal oscillator startup) as described in Section 12.3, "Receiver On/Off Control."

Table 19. Receiver On Time Definition

| RON[3:0] | Receiver On Time: $\mathbf{N} \mathbf{x 5 1 2} \mathbf{x} \mathbf{T}_{\text {digclk }}$ |
| :---: | :---: |
| 0000 | Forbidden value |
| 0001 | 1 |
| 0010 | 2 |
| $\ldots$ | $\ldots$ |
| 1111 | 15 |

ROFF[2:0] (Receiver Off) define the receiver off time as described in Section 12.3, "Receiver On/Off Control."

Table 20. Receiver Off Time Definition

| ROFF[2:0] | Receiver Off Time: $\mathbf{N} \mathbf{x} \mathbf{T}_{\text {Strobe }}$ |
| :---: | :---: |
| 000 | 1 |
| 001 | 2 |
| 010 | 4 |
| 011 | 8 |
| 100 | 12 |
| 101 | 16 |
| 110 | 32 |
| 111 | 63 |

### 18.5 ID and Header Registers

Figure 32 defines the ID register, ID.

|  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 | $\begin{aligned} & \text { Addr } \\ & \$ 0 \mathrm{~A} \end{aligned}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Bit Name | IDL1 | IDLO | ID5 | ID4 | ID3 | ID2 | ID1 | IDO |  |
| Reset Value | 1 | 1 | 0 | 0 | 0 | 0 | 0 | 0 |  |
| Access | R/W | R/W | R/W | R/W | R/W | R/W | R/W | R/W |  |

Figure 32. ID Register
IDL[1:0] (Identifier Length) sets the length of the identifier, as shown on Table 21.
Table 21. ID Length Selection

| IDL1 | IDL0 | ID Length |
| :---: | :---: | :---: |
| 0 | 0 | 2 bits |
| 0 | 1 | 4 bits |
| 1 | 0 | 5 bits |
| 1 | 1 | 6 bits |

ID[5:0] (Identifier) sets the identifier. The ID is Manchester coded. Its LSB corresponds to the register's LSB, whatever the specified length.
Figure 33 defines the Header register, HEADER.

|  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 | Addr <br> \$0B |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Bit Name | HDL1 | HDLO | HD5 | HD4 | HD3 | HD2 | HD1 | HDO |  |
| Reset Value | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |  |
| Access | R/W | R/W | R/W | R/W | R/W | R/W | R/W | R/W |  |

Figure 33. HEADER Register
HDL[1:0] (Header Length) sets the length of the header, as shown on Table 22.

Table 22. Header Length Selection

| HDL1 | HDLO | HD Length |
| :---: | :---: | :---: |
| 0 | 0 | 1 bits |
| 0 | 1 | 2 bits |
| 1 | 0 | 4 bits |
| 1 | 1 | 6 bits |

HD[5:0] (Header) sets the header. The header is Manchester coded. Its LSB corresponds to the register's LSB, whatever the specified length.

### 18.6 RSSI Register

Figure 34 describes the RSSI Result register, RSSI.

| Bit Name | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 | Addr \$0C |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | RSSI7 | RSSI6 | RSSI5 | RSSI4 | RSSI3 | RSSI2 | RSSI1 | RSSIO |  |
| Reset Value | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |  |
| Access | R | R | R | R | R | R | R | R |  |

Figure 34. RSSI Register
Bits $\operatorname{RSSI}[7: 4]$ contain the result of the analog-to-digital conversion of the signal measured at the LNA output.

Bits RSSI[3:0] contain the result of the analog-to-digital conversion of the signal measured at the IF filter output.

## 19 Bank Access and Register Mapping

Registers are physically mapped following a byte organization. The possible address space is 32 bytes. The base address is specified in the command byte. This is then incremented internally to address each register, up to the number of registers specified by $\mathrm{N}[1: 0]$, also specified by this command byte. All registers can then be scanned, whatever the type of transmission (read or write); however, writing to read-only bits or registers has no effect. When the last implemented address is reached, the internal address counter automatically loops back to the first mapped address (\$00).
At any time, it is possible to write or read the content of any register of Bank A and Bank B. Register access is defined as follows:

R/W Bit can be read and written.
R Bit can be read. Write has no effect on bit value.
RR Bit can be read. Read or write resets the value.
$R[A] \quad$ Bit can be read. This returns the same value as Bank A.
RR [A] Bit can be read. This returns the same value as Bank A. Read or write resets the value.

## Bank Access and Register Mapping

Table 23. Access to Specific Bits

| Bit | Bank | Byte | Access | Comment |
| :---: | :---: | :---: | :---: | :--- |
| RESET | A | CONFIG1 | R/W | Available in BANKA. |
| OLS | A, B | CONFIG3 | R-R[A] | Bit value is the real time status of the PLL, BANKA, <br> and BANKB access reflect the same value. |
| LDVS | A, B | CONFIG3 | RR-RR[A\} | Bit value is the latched value of the low-voltage <br> detector. Read or write from any bank resets value. |
| SOE | A, B | CONFIG2 | R/W-R[A\} | SOE can be modified in BANKA. Access from BANKB <br> reflects BANKA value. |
| RSSIx | A, B | RSSI | R-R[A $\}$ | RSSI value is directly read from RSSI converter. <br> Reflected value is the same whatever the active byte. |





Figure 35. Bank Registers (continued)

## 20 Transition Time

Table 24 details the different times that must be considered for a given transition in the state machine, once the logic conditions for that transition are met.

Table 24. Transition Time Definition

| Transition <br> State $x$-> y | Crystal Oscillator Startup Time, Parameter 5.10 | PLL Timing | Receiver Preamble Time ${ }^{1}$ | Receiver On-to-Off Time, Parameter 1.12 |
| :---: | :---: | :---: | :---: | :---: |
| Standby to SPI running, state $60->1$ | $\checkmark$ |  |  |  |
| Standby to receiver running, states $5->5 \mathrm{~b}, 20->21$ | $\checkmark$ | Lock time parameter 5.9 | $\checkmark$ |  |
| Off to receiver running, states $0->0 b, 10->11$ | $\checkmark$ | Lock time parameter 5.9 | $\checkmark$ |  |
| Configuration to receiver running, states 1 -> (0b, 5b, 11, 21) |  | 0 or lock time parameter 5.1 or lock time parameter $5.9^{2}$ | $\checkmark$ |  |
| Configuration to transmitter mode, state 1 -> 30 |  | 0 or lock time parameter 5.1 or lock time parameter $5.9^{2}$ |  |  |
| Receiver running to configuration mode, state (0b, 5b, 11, 12, 13, 21, 22, 23) -> 1, | When CONFB=0, the transition from receive mode to configuration mode is immediate. |  |  |  |
| Transmitter mode to configuration mode, state 30 -> 1 | When CONFB=0, the transition from transmit mode to configuration mode is immediate. |  |  |  |
| Receiver running to standby mode, state 5b -> 5, (21, 22, 23) -> 20 |  |  |  | $\checkmark$ |
| Receiver running to off mode, state $0 b->0,(11,12,13)$-> 10 |  |  |  | $\checkmark$ |

## NOTES:

1 See Section 12.2.3, "Frame Format."
2 Depending on the PLL status before entering configuration mode. For example, the transition time from standby to receiver running (FSK modulation, $19.2 \mathrm{kBd}, \mathrm{AFFC}=0$, data manager enabled) is: $0.6 \mathrm{~ms}+50 \mu \mathrm{~s}+(3+1) / 19.2 \mathrm{k}=970 \mu \mathrm{~s}$.

## Electrical Characteristics

## 21 Electrical Characteristics

### 21.1 General Parameters

Operating supply voltage and temperature range see Table 3. Values refer to the circuit recommended in the application schematic (see Figure 47, Figure 48, Figure 51, Figure 53 through Figure 54), unless otherwise specified. Typical values reflect average measurement at $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.

|  | Parameter | Test Conditions Comments | Limits |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max |  |
| 1.2 | Supply current in receive mode | Receiver on | - | 10.3 | 13 | mA |
| 1.3 |  | Strobe oscillator only | - | 24 | 50 | $\mu \mathrm{A}$ |
| 1.4 | Supply current in transmit mode | Continuous wave (CW) OLA[1:0\}=00 | - | 13.5 | 17.5 | mA |
| 1.5 |  | No power output | - | 6.1 | 8 | mA |
| 1.6 | Supply current in standby mode | $-40^{\circ} \mathrm{C} \leq \mathrm{T}_{\mathrm{A}} \leq 25^{\circ} \mathrm{C}$ | - | 260 | 700 | nA |
| 1.8 |  | $\mathrm{T}_{\mathrm{A}}=85^{\circ} \mathrm{C}$ | - | 800 | 1200 | nA |
| 1.9 | Supply current in LVD mode | LVDE = 1 | - | 35 | 50 | $\mu \mathrm{A}$ |
| 1.12 | Receiver on-to-off time | Supply current reduced to 10\% | - | 100 | - | $\mu \mathrm{s}$ |
| 1.13 | VCC2 voltage regulator output | $2.7 \mathrm{~V}<\mathrm{V}_{\mathrm{CC}}$ | 2.4 | 2.6 | 2.8 | V |
| 1.14 |  | $2.1 \mathrm{~V} \leq \mathrm{V}_{\mathrm{CC}} \leq 2.7 \mathrm{~V}$ | - | $\mathrm{V}_{\text {cc }}-0.1$ | - | V |
| 1.15 | VCCDIG2 voltage regulator output | Circuit in standby mode $\left(\mathrm{V}_{\mathrm{CCDIG}}=3 \mathrm{~V}\right)$ | - | $\begin{gathered} 0.7 x \\ \mathrm{~V}_{\mathrm{CCDIG}} \end{gathered}$ | - | V |
| 1.16 |  | Circuit in all other modes | 1.4 | 1.6 | 1.8 | V |
| 1.19 | Voltage on VCC (Preregulator output) | Receive mode with VCCIN=5V | 2.4 | - | - | V |

### 21.2 Receiver: RF Parameters

RF parameters assume a matching network between test equipment and the D.U.T, and apply to all bands unless otherwise specified.

Operating supply voltage and temperature range see Table 3. Values refer to the circuit recommended in the application schematic (see Figure 47, Figure 48, Figure 51, Figure 53 through Figure 54), unless otherwise specified. Typical values reflect average measurement at $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.

|  | Parameter | Test Conditions, Comments | Limits |  |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ |  |  |  |
| 2.2 | OOK sensitivity at 315 MHz | DME = 1, DSREF = 1, <br> $\mathrm{DR}=4.8 \mathrm{kbps}, \mathrm{PER}=0.1$ | - | -104 | -99 | -97 | dBm |

Operating supply voltage and temperature range see Table 3. Values refer to the circuit recommended in the application schematic (see Figure 47, Figure 48, Figure 51, Figure 53 through Figure 54), unless otherwise specified. Typical values reflect average measurement at $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.

|  | Parameter | Test Conditions, Comments | Limits |  |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max (FCE, FJE) |  |  |
| 2.40 | OOK sensitivity at 434 MHz | $\begin{aligned} & \mathrm{DME}=1, \mathrm{DSREF}=1, \\ & \mathrm{DR}=4.8 \mathrm{kbps}, \mathrm{PER}=0.1 \end{aligned}$ | - | -103.5 | -98 | -96 | dBm |
| 2.41 | OOK sensitivity at 868 MHz | $\begin{aligned} & \mathrm{DME}=1, \mathrm{DSREF}=1, \\ & \mathrm{DR}=4.8 \mathrm{kbps}, \mathrm{PER}=0.1 \end{aligned}$ | - | -103 | -98 | -96 | dBm |
| 2.42 | OOK sensitivity at 916 MHz | $\begin{aligned} & \mathrm{DME}=1, \mathrm{DSREF}=1, \\ & \mathrm{DR}=4.8 \mathrm{kbps}, \mathrm{PER}=0.1 \end{aligned}$ | - | -103 | -98 | -96 | dBm |
| 2.24 | FSK sensitivity at 315 MHz | $\begin{aligned} & \mathrm{DME}=1, \mathrm{DSREF}=1, \\ & \mathrm{DR}=4.8 \mathrm{kbps}, \\ & \mathrm{DF}_{\text {carrier }}= \pm 64 \mathrm{kHz}, \mathrm{PER}=0.1 \end{aligned}$ | - | -106.5 | -102 | -100 | dBm |
| 2.50 | FSK sensitivity at 434 MHz | $\begin{aligned} & \mathrm{DME}=1, \mathrm{DSREF}=1, \\ & \mathrm{DR}=4.8 \mathrm{kbps}, \\ & \mathrm{DF}_{\text {carrier }}= \pm 64 \mathrm{kHz}, \mathrm{PER}=0.1 \end{aligned}$ | - | -105.5 | -101 | -99 | dBm |
| 2.51 | FSK sensitivity at 868 MHz | $\begin{aligned} & \text { DME }=1, \text { DSREF }=1, \\ & \text { DR }=4.8 \mathrm{kbps}, \\ & \mathrm{DF}_{\text {carrier }}= \pm 64 \mathrm{kHz}, \text { PER }=0.1 \end{aligned}$ | - | -104.5 | -100 | -98 | dBm |
| 2.52 | FSK sensitivity at 916 MHz | $\begin{aligned} & \hline \text { DME }=1, \text { DSREF }=1, \\ & \text { DR }=4.8 \mathrm{kbps}, \\ & \mathrm{DF}_{\text {carrier }}= \pm 64 \mathrm{kHz}, \text { PER }=0.1 \end{aligned}$ | - | -105.4 | -102 | -100 | dBm |
| 2.35 | Sensitivity improvement in RAW mode | DME $=0$ | - | 0.6 | - | - | dB |
| 2.36 | Duty Cycle for Manchester coded data |  | 47 | - | 53 | 53 | \% |
| 2.37 | Data Rate ${ }^{1}$ |  | 2 | - | 22.6 | 22.6 | kbps |
| 2.38 | FSK deviation range |  | 32 | 64 | 170 | 170 | kHz |
| 2.5 | Sensitivity reduction | ILA[1:0] = 00 | - | 0 | - | - | dB |
| 2.6 |  | ILA[1:0] = 01 | - | 8 | - | - | dB |
| 2.7 |  | ILA[1:0] = 10 | - | 16 | - | - | dB |
| 2.8 |  | ILA[1:0] = 11 | - | 30 | - | - | dB |
| 2.9 | In-band jammer desensitization | Sensitivity reduced by 3 dB CW jammer at $\mathrm{F}_{\text {carrier }} \pm 50 \mathrm{kHz} / \mathrm{OOK}$ | - | -4 | - | - | dBc |
| 2.60 |  | Sensitivity reduced by 3 dB CW jammer at $\mathrm{F}_{\text {carrier }} \pm 50 \mathrm{kHz} / \mathrm{FSK}$ | - | -6 | - | - | dBc |
| 2.11 | Out-of-band jammer desensitization | Sensitivity reduced by 3dB CW jammer at $\mathrm{F}_{\text {carrier }} \pm 1 \mathrm{MHz}$ | - | 37 | - | - | dBc |
| 2.12 |  | Sensitivity reduced by 3dB CW jammer at $\mathrm{F}_{\text {carrier }} \pm 2 \mathrm{MHz}$ | - | 40 | - | - | dBc |
| 2.13 | RFIN parallel resistance | Receive mode | - | 300 | - | - | $\Omega$ |

## Electrical Characteristics

Operating supply voltage and temperature range see Table 3. Values refer to the circuit recommended in the application schematic (see Figure 47, Figure 48, Figure 51, Figure 53 through Figure 54), unless otherwise specified. Typical values reflect average measurement at $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.

|  | Parameter | Test Conditions, Comments | Limits |  |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max (FCE, FJE) | Max (FCAE, FJAE) |  |
| 2.14 | RFIN parallel resistance | Transmit mode | 1300 | - | - | - | $\Omega$ |
| 2.15 | RFIN parallel capacitance | Receive and transmit modes | - | 1.2 | - | - | pF |
| 2.17 | Maximum detectable signal, OOK | Modulation depth: 99\%, level measured on a NRZ '1' | -25 | - | - | - | dBm |
| 2.25 | Maximum detectable signal, FSK | $\Delta \mathrm{F}_{\text {carrier }}= \pm 64 \mathrm{kHz}$ | -10 | - | - | - | dBm |
| 2.18 | Image frequency rejection | 304-434 MHz | 20 | 36 | - | - | dB |
| 2.19 |  | $868-915 \mathrm{MHz}$ | 15 | 20 | - | - | dB |

NOTES:
See Table 10 for additional information.


Figure 36. OOK Sensitivity Variation Versus Temperature


Figure 37. OOK Sensitivity Variation Versus Voltage


Figure 38. FSK Sensitivity Variation Versus Temperature

## Electrical Characteristics



Figure 39. FSK Sensitivity Variation Versus Voltage


Figure 40. OOK Sensitivity Variation Versus Data Rate


Figure 41. FSK Sensitivity Variation Versus Data Rate

## Electrical Characteristics



Figure 42. FSK Sensitivity Variation Versus Frequency Deviation

### 21.3 Receiver Parameters

Operating supply voltage and temperature range see Table 3. Values refer to the circuit recommended in the application schematics Figure 47, Figure 48, Figure 53 through Figure 54), unless otherwise specified. Typical values reflect average measurement at $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.

|  | Parameter | Test Conditions Comments | Limits |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max |  |
|  | Receiver: IF filter, IF Amplifier, FM-to-AM Converter and Envelope Detector |  |  |  |  |  |
| 3.1 | IF center frequency | Refer to Section 9, "Frequency Planning". | - | 1.5 | - | MHz |
| 3.2 | IF bandwidth at -3dB |  | - | 380 | - | kHz |
| 3.3 | IF cut-off low frequency at -3 dB |  | - | - | 1.387 | MHz |
| 3.4 | IF cut-off high frequency at -3 dB |  | 1.635 | - | - | MHz |
| 3.12 | Recovery time from strong signal | OOK modulation, 2.4 kbps , FAGC $=0$, input signal from -50 dBm to -100 dBm | - | 15 | - | ms |

Operating supply voltage and temperature range see Table 3. Values refer to the circuit recommended in the application schematics Figure 47, Figure 48, Figure 53 through Figure 54), unless otherwise specified. Typical values reflect average measurement at $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.

|  | Parameter | Test Conditions Comments | Limits |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max |  |
|  | Receiver: Analog and Digital RSSI |  |  |  |  |  |
| 3.51 | Analog RSSI output signal for Input signal @-108 dBm | Measured on RSSIOUT | 380 | - | 650 | mV |
| 3.52 | Analog RSSI output signal for Input signal @-100 dBm |  | 420 | - | 700 | mV |
| 3.53 | Analog RSSI output signal for Input signal @-70 dBm |  | 850 | - | 1200 | mV |
| 3.54 | Analog RSSI output signal for Input signal @-28dBm |  | 1000 | - | 1300 | mV |
| 3.55 | Digital RSSI Registers for Input signal @-108 dBm | RSSI [0:3] | 0 | - | 2 |  |
| 3.56 | Digital RSSI Registers for Input signal @-100 dBm |  | 0 | - | 3 |  |
| 3.57 | Digital RSSI Registers for Input signal @-70 dBm |  | 9 | - | 13 |  |
| 3.58 | Digital RSSI Registers for Input signal @-28 dBm |  | 13 | - | 16 |  |
| 3.59 | Digital RSSI Registers for Input signal @-70 dBm | RSSI [4:7] | 0 | - | 2 |  |
| 3.6 | Digital RSSI Registers for Input signal @-50 dBm |  | 4 | - | 8 |  |
| 3.61 | Digital RSSI Registers for Input signal @-24 dBm |  | 13 | - | 15 |  |

### 21.4 Transmitter: RF Parameters

RF parameters assume a matching network between test equipment and the D.U.T, and apply to all bands unless otherwise specified.

## Electrical Characteristics

Operating supply voltage and temperature range see Table 3. Values refer to the circuit recommended in the application schematic (see Figure 51, Figure 54), unless otherwise specified. Typical values reflect average measurement at $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}$, $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.

|  | Parameter | Test Conditions Comments | Limits |  |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | Min (FCAE, FJAE) | Typ | Max |  |
| 4.1 | Output power at 315 MHz | $\begin{aligned} & \mathrm{OLA}[1: 0]=00, \mathrm{~V}_{\mathrm{CC}}=3.0 \mathrm{~V}, \\ & \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C} \end{aligned}$ | 4 | 2 | 7.25 | 11 | dBm |
| 4.16 | Output power at 434 MHz | $\begin{aligned} & \mathrm{OLA}[1: 0]=00, \mathrm{~V}_{\mathrm{CC}}=3.0 \mathrm{~V}, \\ & \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C} \end{aligned}$ | 3.5 | 1.5 | 6.8 | 10 | dBm |
| 4.2 | Output power at 868 MHz | $\begin{aligned} & \mathrm{OLA}[1: 0]=00, \mathrm{~V}_{\mathrm{CC}}=3.0 \mathrm{~V}, \\ & \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C} \end{aligned}$ | 2.3 | 0.3 | 5.7 | 10 | dBm |
| 4.25 | Output power at 916 MHz | $\begin{aligned} & \mathrm{OLA}[1: 0]=00, \mathrm{~V}_{\mathrm{CC}}=3.0 \mathrm{~V}, \\ & \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C} \end{aligned}$ | - | - | 5.8 | - | dBm |
| 4.20 | Output power attenuation | OLA[1:0] = 00 | - | - | 0 | - | dB |
| 4.3 |  | OLA[1:0] = 01 | - | - | 6 | - | dB |
| 4.4 |  | OLA[1:0] = 10 | - | - | 12 | - | dB |
| 4.5 |  | OLA[1:0] = 11 | - | - | 25 | - | dB |
| 4.10 | Harmonic 2 level at 315 MHz | OLA[1:0] = 00 | - | - | -33 | - | dBc |
| 4.17 | Harmonic 2 level at 434 MHz | OLA[1:0] = 00 | - | - | -32 | - | dBc |
| 4.11 | Harmonic 2 level at 868 MHz | OLA[1:0] = 00 | - | - | -50 | - | dBc |
| 4.20 | Harmonic 2 level at 916 MHz | OLA[1:0] = 00 | - | - | -54 | - | dBc |
| 4.12 | Harmonic 3 level at 315 MHz | OLA[1:0] = 00 | - | - | -41 | - | dBc |
| 4.18 | Harmonic 3 level at 434 MHz | OLA[1:0] = 00 | - | - | -49 | - | dBc |
| 4.13 | Harmonic 3 level at 868 MHz | OLA[1:0] = 00 | - | - | -53 | - | dBc |
| 4.21 | Harmonic 3 level at 916 MHz | OLA[1:0] = 00 | - | - | -58 | - | dBc |
| 4.30 | Spurious level at $315 \mathrm{MHz} \pm \mathrm{F}_{\text {ref }}$ | OLA[1:0] = 00 | - | - | -54 | - | dBm |
| 4.14 | Spurious level at $434 \mathrm{MHz} \pm \mathrm{F}_{\text {ref }}$ | OLA[1:0] = 00 | - | - | -57 | - | dBm |
| 4.15 | Spurious level at $868 \mathrm{MHz} \pm \mathrm{F}_{\text {ref }}$ | OLA[1:0] = 00 | - | - | -56 | - | dBm |
| 4.31 | Spurious level at $916 \mathrm{MHz} \pm \mathrm{F}_{\text {ref }}$ | OLA[1:0] = 00 | - | - | -57 | - | dBm |
| 4.6 | Output rise/fall time |  | - | - | 3 | - | $\mu \mathrm{s}$ |
| 4.7 | RFOUT parallel resistance at 315 MHz | OLA[1:0] = 00, RX mode | - | - | 2500 | - | $\Omega$ |
| 4.71 | RFOUT parallel resistance at 434 MHz | OLA[1:0] = 00, RX mode | - | - | 2100 | - | $\Omega$ |
| 4.72 | RFOUT parallel resistance at 868 MHz | OLA[1:0] = 00, RX mode | - | - | 1300 | - | $\Omega$ |
| 4.73 | RFOUT parallel resistance at 916 MHz | OLA[1:0] = 00, RX mode | - | - | 1200 | - | $\Omega$ |
| 4.8 | RFOUT optimum load resistance at 315 MHz | OLA[1:0] = 00, TX mode | - | - | 310 | - | $\Omega$ |

Operating supply voltage and temperature range see Table 3. Values refer to the circuit recommended in the application schematic (see Figure 51, Figure 54), unless otherwise specified. Typical values reflect average measurement at $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}$, $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.

|  | Parameter | Test Conditions Comments | Limits |  |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min FJE) | $\begin{aligned} & \operatorname{Min} \\ & \text { (FCAE, } \\ & \text { FJAE) } \end{aligned}$ | Typ | Max |  |
| 4.81 | RFOUT optimum load resistance at 434 MHz | OLA[1:0] = 00, TX mode | - | - | 310 | - | $\Omega$ |
| 4.82 | RFOUT optimum load resistance at 868 MHz | OLA[1:0] = 00, TX mode | - | - | 310 | - | $\Omega$ |
| 4.83 | RFOUT optimum load resistance at 916 MHz | OLA[1:0] = 00, TX mode | - | - | 310 | - | $\Omega$ |
| 4.9 | RFOUT parallel capacitance | Receive and transmit modes | - | - | 1 | - | pF |



Figure 43. Output Power Versus Temperature

## Electrical Characteristics



Figure 44. Output Power Versus Supply Voltage

### 21.5 PLL \& Crystal Oscillator

Operating supply voltage and temperature range see Table 3. Values refer to the circuit recommended in the application schematic (see Figure 47 to Figure 54 through Figure 54), unless otherwise specified. Typical values reflect average measurement at $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.

|  | Parameter | Test Conditions Comments | Limits |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max |  |
| 5.9 | PLL lock time | RF frequency $\pm 25 \mathrm{kHz}$ | - | 50 | 100 | $\mu \mathrm{s}$ |
| 5.1 | Toggle time between 2 frequencies | RF frequency step $<1.5 \mathrm{MHz}$, RF frequency $\pm 25 \mathrm{kHz}$ | - | 30 | - | $\mu \mathrm{s}$ |
| 5.21 | Occupied bandwidth @ 99\% | OOK 1.2 kbps | - | 58 | - | kHz |
| 5.22 |  | OOK 19.2 kbps | - | 248 | - | kHz |
| 5.23 |  | FSK 128 kHz , 1.2 kbps | - | 160 | - | kHz |
| 5.24 |  | FSK 128 kHz, 19.2 kbps | - | 278 | - | kHz |
| 5.10 | Crystal oscillator startup time |  | - | 0.6 | 1.2 | ms |
| 5.8 | Crystal series resistance |  | - | - | 120 | $\Omega$ |

Examples of crystal characteristics are given in Table 25.

Table 25. Typical Crystal Reference and Characteristics

| Parameter | Reference \& Type |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: |
|  | 315 MHz | 434 MHz | 868 MHz |  |
|  | LN-G102-1183 NX5032GA NDK | $\begin{gathered} \text { LN-G102-1182 } \\ \text { NX5032GA } \\ \text { NDK } \end{gathered}$ | EXSO0A-01654 NX5032GA NDK |  |
| Frequency | 17.5814 | 24.19066 | 24.16139 | MHz |
| Load capacitance | 8 | 8 | 8 | pF |
| ESR | 25 | 15 | <70 | $\Omega$ |

### 21.6 Strobe Oscillator (SOE = 1)

Operating supply voltage and temperature range see Table 3. Values refer to the circuit recommended in the application schematic (see Figure 48 through Figure 46, Figure 50), unless otherwise specified. Typical values reflect average measurement at $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.

|  | Parameter | Test Conditions Comments | Limits |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max |  |
| 6.1 | Period range | $\mathrm{T}_{\text {Strobe }}=10^{6} . \mathrm{C3}$ | 0.1 | - | - | ms |
| 6.2 | External capacitor C3 |  | 0.1 | - | 10 | nF |
| 6.3 | Sourced/sink current | With 1\% resistor R13 | - | 1 | - | $\mu \mathrm{A}$ |
| 6.4 | High threshold voltage |  | - | 1 | - | V |
| 6.5 | Low threshold voltage |  | - | 0.5 | - | V |
| 6.6 | Overall timing accuracy | With 1\% resistor R13 \& 5\% capacitor C3, <br> $\pm 3$ sigma variations | -14.2 | - | 15.8 | \% |

## Electrical Characteristics

### 21.7 Digital Input: CONFB, MOSI, SCLK, SEB, STROBE, RSSIC

Operating supply voltage and temperature range see Table 3. Values refer to the circuit recommended in the application schematic (see Figure 47 to Figure 54 through Figure 54), unless otherwise specified. Typical values reflect average measurement at $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.

|  | Parameter | Test Conditions Comments | Limits |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max |  |
| 7.7 | Input low voltage | MOSI, SCLK, SEB, RSSIC ${ }^{(1)}$ | - | - | $0.4 \times \mathrm{V}_{\mathrm{CC} 2}$ | V |
| 7.8 | Input high voltage |  | $0.8 \times \mathrm{V}_{\mathrm{CC} 2}$ | - | - | V |
| 7.9 | Input hysteresis |  | $0.1 \times \mathrm{V}_{\mathrm{CC} 2}$ | - | - | V |
| 7.10 | Input low voltage | CONFB, STROBE ${ }^{2}$ | - | - | $0.4 \times \mathrm{V}_{\text {CCDIG2 }}$ | V |
| 7.11 | Input high voltage |  | $0.8 \times \mathrm{V}_{\text {CCDIG2 }}$ | - | - | V |
| 7.12 | Input hysteresis |  | $0.1 \times \mathrm{V}_{\text {CCDIG2 }}$ | - | - | V |
| 7.5 | Sink current | Configuration, receive, transmit modes | 1 | - | 100 | nA |
| 7.6 |  | standby or LVD modes | 0.5 | - | 10 | nA |

NOTES:
1 Input levels of those pins are referenced to $\mathrm{V}_{\mathrm{CC}}$ which depends upon $\mathrm{V}_{\mathrm{CC}}$ (see Section 5, "Power Supply").
2 Input levels of those pins are referenced to $\mathrm{V}_{\text {CCDIG2 }}$ which depends upon the circuit state (see Section 5, "Power Supply").

### 21.8 Digital Output

Operating supply voltage and temperature range see Table 3. Values refer to the circuit recommended in the application schematic (see Figure 47 to Figure 54 through Figure 54), unless otherwise specified. Typical values reflect average measurement at $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.

|  | Parameter | Test Conditions Comments | Limits |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max |  |
|  | Digital Output: DATACLK, LVD, MISO, MOSI, SCLK |  |  |  |  |  |
| 8.1 | Output low voltage | $\left.\right\|_{\text {ILOADI }}=50 \mu \mathrm{~A}$ | - | - | $0.2 \times \mathrm{V}_{\text {CCIO }}$ | V |
| 8.2 | Output high voltage |  | $0.8 \times \mathrm{V}_{\mathrm{CCIO}}$ | - | - | V |
| 8.3 | Fall and rise time | From $10 \%$ to $90 \%$ of the output swing, $C_{\text {LOAD }}=10 \mathrm{pF}$ | - | 80 | 150 | ns |
|  | Digital Output: SWITCH ( $\left.\mathrm{V}_{\mathrm{CC}}=3 \mathrm{~V}\right)$ |  |  |  |  |  |
| 8.4 | Output low voltage | ${ }_{\text {ILOADI }}=50 \mu \mathrm{~A}$ | - | - | $0.2 \times \mathrm{V}_{\mathrm{CC}}$ | V |
| 8.5 | Output high voltage |  | $0.8 \times \mathrm{V}_{\text {CC }}$ | - | - | V |

### 21.9 Digital Interface Timing

Operating supply voltage and temperature range see Table 3. Values refer to the circuit recommended in the application schematic (see Figure 47 to Figure 54 through Figure 54), unless otherwise specified. Typical values reflect average measurement at $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.

|  | Parameter | Test Conditions Comments | Limits |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max |  |
| 9.2 | SCLK period |  | 1 | - | - | $\mu \mathrm{S}$ |
| 9.8 | Configuration enable time |  | 20 | - | - | $\mu \mathrm{S}$ |
| 9.3 | Enable lead time | Crystal oscillator is running. | $3 \times \mathrm{T}_{\text {digclk }}{ }^{1}$ | - | - | $\mu \mathrm{S}$ |
| 9.4 | Enable lag time |  | 100 | - | - | ns |
| 9.5 | Sequential transfer delay |  | 100 | - | $\square^{2}$ | ns |
| 9.6 | Data hold time | Receive mode, DME = 1, from SCLK to MOSI | $3 \times \mathrm{T}_{\text {digclk }}{ }^{1}$ | - | - | $\mu \mathrm{S}$ |
| 9.7 | Data setup time | Configuration mode, from SCLK to MISO | - | - | 100 | ns |
| 9.9 |  | Configuration mode, from SCLK to MOSI | 120 | - | - | ns |
| 9.10 | Data setup time | Configuration mode, from SCLK to MOSI | 100 | - | - | ns |

## NOTES:

1 See Section 9.1, "Clock Generator" for $\mathrm{T}_{\text {digclk }}$ values.
2 The digital interface can be used in SPI burst protocol, i.e., with a continuous clock on SCLK port. For example, one (or more) read access followed by one (or more) write access and so on. In this case and for a practical use, the pulse required on CONFB between accesses must be higher than 100 ns only if STROBE signal is always set to high level.


Figure 45. Digital Interface Timing Diagram in Configuration Mode


Figure 46. Digital Interface Timing Diagram in Receive Mode (DME =1)

## 22 Application Schematics

Examples of application schematics are proposed for different uses: Receiver, Transmitter, Transceiver.
Note: The external pullup resistor set on SEB pin (R2) is not mandatory. Instead of R2, an external pulldown resistor of 10 k may be connected between SEB pin and ground.

### 22.1 Receiver Schematics

Figure 43 and Figure 44 show the application schematic in receive mode for 3 V operation.

Figure 45 and Figure 46 show the application schematic in receive mode for 5 V operation.

### 22.1.1 Receiver Schematics in 3 V Operation-MCU Controls Wakeup



Figure 47. MC33696 Application Schematic (3 V)
The ON/OFF sequencing in receive mode is controlled by driving a low or high level by the MCU on STROBE pin.

### 22.1.2 Receiver Schematics in 3V Operation—Strobe Oscillator Mode



Figure 48. MC33696 Application Schematic in Strobe mode (3 V)
The ON/OFF sequencing in receive mode is controlled internally. The STROBE pin from the MCU has to be configured in high impedance and wakeup mode is available when SOE bit is enabled.

### 22.1.3 Receiver Schematics in 5 V Operation-MCU Controls Wakeup



Figure 49. MC33696 Application Schematic (5 V)
The ON/OFF sequencing in receive mode is controlled by driving a low or high level by the MCU on STROBE pin.

### 22.1.4 Receiver Schematics in 5 V Operation—Strobe Oscillator Mode



Figure 50. MC33696 Application Schematic in Strobe Mode (5 V)
The ON/OFF sequencing in receive mode is controlled internally. The STROBE pin from the MCU has to be configured in high impedance and wake up mode is available when SOE bit is enabled.

### 22.2 Transmitter Schematics

### 22.2.1 Transmitter Schematics in 3 V Operation

Figure 51 shows the application schematic in transmit mode for 3 V operation.


Figure 51. MC33696MC33596 Application Schematic (3 V) in Transmit Mode Only

## Application Schematics

### 22.2.2 Transmitter Schematics in 5 V Operation

Figure 52 shows the application schematic in transmit mode for 5 V operation.


Figure 52. MC33696MC33596 Application Schematic (5 V) in Transmit Mode Only

### 22.3 Transceiver Schematics

### 22.3.1 Transceiver Schematics in 3 V Operation

Figure 53 shows the application schematic in transceiver mode for 3 V operation.


Figure 53. MC33696 Application Schematic (3 V) in Transceiver Mode
The ON/OFF sequencing for the receiver is controlled by driving a low or high level by the MCU on STROBE pin.

### 22.3.2 Transceiver Schematics in 5 V Operation

Figure 54 shows the application schematic in transceiver mode for 5 V operation.


Figure 54. MC33696 Application Schematic (5 V) in Transceiver Mode
The ON/OFF sequencing for the receiver is controlled by driving a low or high level by the MCU on STROBE pin.

## 23 PCB Design Recommendations

Pay attention to the following points and recommendations when designing the layout of the PCB.

- Ground Plane
- If you can afford a multilayer PCB, use an internal layer for the ground plane, route power supply and digital signals on the last layer, with RF components on the first layer.
- Use at least a double-sided PCB.
- Use a large ground plane on the opposite layer.
- If the ground plane must be cut on the opposite layer for routing some signals, maintain continuity with another ground plane on the opposite layer and a lot of via to minimize parasitic inductance.
- Power Supply, Ground Connection and Decoupling
- Connect each ground pin to the ground plane using a separate via for each signal; do not use common vias.
- Place each decoupling capacitor as close to the corresponding VCC pin as possible (no more than 2-3 mm away).
- Locate the VCCDIG2 decoupling capacitor (C10) directly between VCCDIG2 (pin 14) and GND (pin 16).
- GNDPA1 and GNDPA2 inductance to ground should be minimum. If possible, use two via for each pin.
- RF Tracks, Matching Network and Other Components
- Minimize any tracks used for routing RF signals.
- Locate crystal X1 and associated capacitors C6 and C7 close to the MC33696. Avoid loops occurring due to component size and tracks. Avoid routing digital signals in this area.
- Use high frequency coils with high Q values for the frequency of operation (minimum of 15). Validate any change of coil source.
- Track between RFOUT and RFIN should be as short as possible to minimize lost in TX mode.


## NOTE

The values indicated for the matching network have been computed and tuned for the MC33696 RF Modules available for MC33696 evaluation. Matching networks should be retuned if any change is made to the PCB (track width, length or place, or PCB thickness, or component value). Never use, as is, a matching network designed for another PCB.

## Case Outline Dimensions

## 24 Case Outline Dimensions

### 24.1 LQFP32 Case



| $\begin{gathered} \text { © FREESCALE SEMICONDUCTOR, INC. } \\ \text { ALL RIGHTS RESERVED. } \end{gathered}$ |  | MECHANICAL OUTLINE | PRINT VERSION NOT TO SCALE |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
| TITLE: | $\begin{aligned} & \text { LQFP, } 32-\text { LEAD, } \\ & 5 \times 5 \times 1.4 \text { PKG } \end{aligned}$ | DOCUMENT NO: 98ASH70471A |  | REV: C <br> 02 JUN 2005 |  |
|  |  | CASE NUMB | 873C-01 |  |  |
|  |  | STANDARD: JEDEC MS-026-BAA EIAJ ED-7404A |  |  |  |



SECTION JーJ

| $\begin{aligned} & \text { © FREESCALE SEMICONDUCTOR, } \\ & \text { ALL RIGHTS RESERVED } \end{aligned}$ |  | INC. | MECHANICAL OUTLINE | PRINT VERSION NOT TO SCALE |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| TITLE | $\begin{aligned} & \text { LQFP, } 32-\text { LEAD, } \\ & 5 \times 5 \times 1.4 \text { PKG } \end{aligned}$ |  | DOCUMENT | 98ASH70471A | REV: C |  |
|  |  |  | CASE NUMB | 873C-01 | 02 JUN | 2005 |
|  |  |  | STANDARD: JEDEC MS-026-BAA EIAJ ED-7404A |  |  |  |

## Case Outline Dimensions

NOTES:

1. DIMENSION ARE IN MILLIMETERS.
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUMS A, B AND D TO BE DETERMINED WHERE THE LEADS EXIT THE PLASTIC BODY AT DATUM PLANE H.
4. DIMENSIONS DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.25 MM PER SIDE. DIMENSIONS ARE MAXIMUM PLASTIC BODY SIZE DIMENSIONS INCLUDING MOLD MISMATCH.
5. DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL NOT CAUSE THE LEAD WIDTH TO EXCEED THE MAXIMUM DIMENSION BY MORE THAN O.O8 MM. DAMBAR CAN NOT BE LOCATED ON THE LOWER RADIUS OR THE FOOT. MINIMUM SPACE BETWEEN A PROTRUSION AND AN ADJACENT LEAD IS 0.07 mM .
6. EXACT SHAPE OF CORNERS MAY VARY.

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| :---: | :---: | :---: | :---: | :---: | :---: |
| TITLE: |  | DOCUMENT NO: 98ASH70471A |  | REV: C <br> 02 JUN 2005 |  |
|  |  | CASE NUMBER: 873C-01 |  |  |  |
|  |  | STANDARD: JEDEC MS-026-BAA EIAJ ED-7404A |  |  |  |

## Case Outline Dimensions

### 24.2 QFN32 Case



| $\begin{aligned} & \text { © FREESCALE SEMICONDUCTOR, INC. } \\ & \text { ALL RIGHTS RESERVED. } \end{aligned}$ | MECHANICAL OUTLINE |  | PRINT VERSION NOT TO SCALE |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
| TITLE: THERMALLY ENHANCED QUAD <br> FLAT NON-LEADED PACKAGE (QFN) <br> 32 TERMINAL, 0.5 PITCH ( $5 \times 5 \times 1$ ) <br> $3.6 \times 3.6 \mathrm{EP}, \mathrm{CASE}$ OUTLINE |  | DOCUMENT NO: 98ARE10566D |  | REV: C <br> 26 FEB 2007 |  |
|  |  | CASE NUMBER: 1582-02 |  |  |  |
|  |  | STANDARD: JEDEC MO-220 VHHD-4 |  |  |  |

## Case Outline Dimensions



DETAIL G
VIEW ROTATED $90^{\circ} \mathrm{CW}$


## Case Outline Dimensions

NOTES:

1. ALL DIMENSIONS ARE IN MILLIMETERS.
2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
3. THE COMPLETE JEDEC DESIGNATOR FOR THIS PACKAGE IS: HF-PQFN.
4. COPLANARITY APPLIES TO LEADS, AND DIE ATTACH PAD.
5. MINIMUM METAL GAP SHOULD BE 0.2 MM.

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| :---: | :---: | :---: | :---: | :---: | :---: |
| TITLE: THERMALLY ENHANCED QUAD FLAT NON-LEADED PACKAGE (QFN) 32 TERMINAL, 0.5 PITCH ( $5 \times 5 \times 1$ ) $3.6 \times 3.6 \mathrm{EP}, \mathrm{CASE}$ OUTLINE |  | DOCUMENT NO: 98ARE10566D |  | REV: C <br> 26 FEB 2007 |  |
|  |  | CASE NUMBER: 1582-02 |  |  |  |
|  |  | STANDARD: JEDEC MO-220 VHHD-4 |  |  |  |

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## Europe, Middle East, and Africa:

Freescale Halbleiter Deutschland GmbH
Technical Information Center
Schatzbogen 7
81829 Muenchen, Germany
+44 1296380456 (English)
+46 852200080 (English)
+49 8992103559 (German)
+33169354848 (French)
www.freescale.com/support

## Japan:

Freescale Semiconductor Japan Ltd.
Headquarters
ARCO Tower 15F
1-8-1, Shimo-Meguro, Meguro-ku,
Tokyo 153-0064
Japan
0120191014 or +81 354379125
support.japan@freescale.com

## Asia/Pacific:

Freescale Semiconductor China Ltd.
Exchange Building 23 F
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Beijing 100022
China
+86 1058798000
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[^0]:    1. Refer to parameter 3.3 found in Section 21.3, "Receiver Parameters."
[^1]:    1. Refer to parameter 5.10 found in Section 21.5, "PLL \& Crystal Oscillator."
    2. Refer to parameter 5.9 found in Section 21.5, "PLL \& Crystal Oscillator."
    3. Refer to preamble definition found in Figure 9.
